



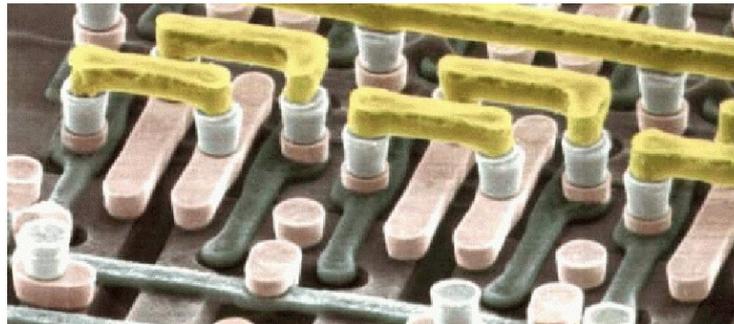
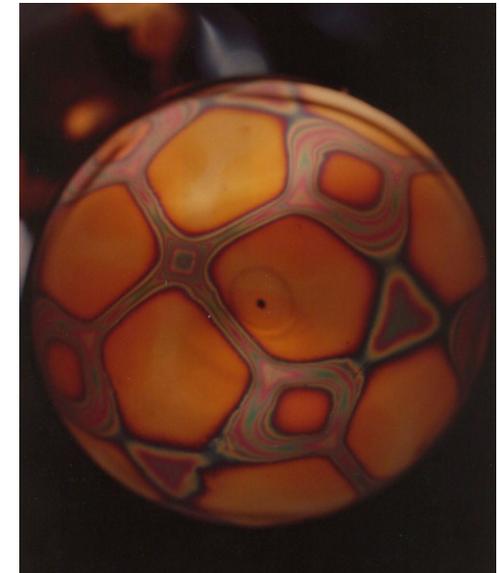
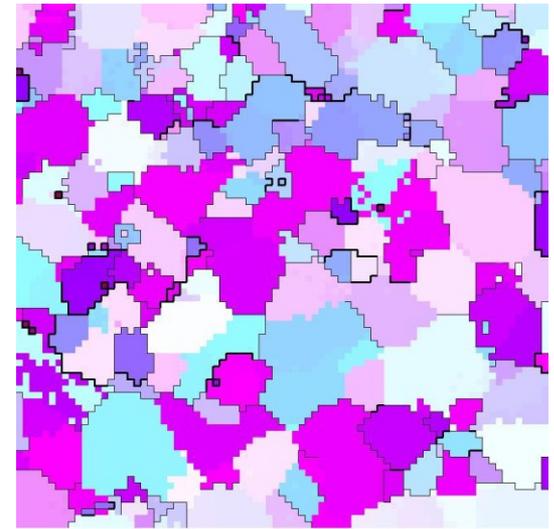
Two words

Spatial Resolution

Spatial resolution essential!

- Most materials *polycrystalline* (0.1-50 μm)
 - Anisotropic
 - Heterogeneous
 - Plastic/elastic deformation/ diffusion/ oxidation/

- Even *within* single and “perfect” crystal:
 - Strain
 - Defects
 - Spontaneously organize to reduce energy



Spatial resolution essential for most advanced energy systems



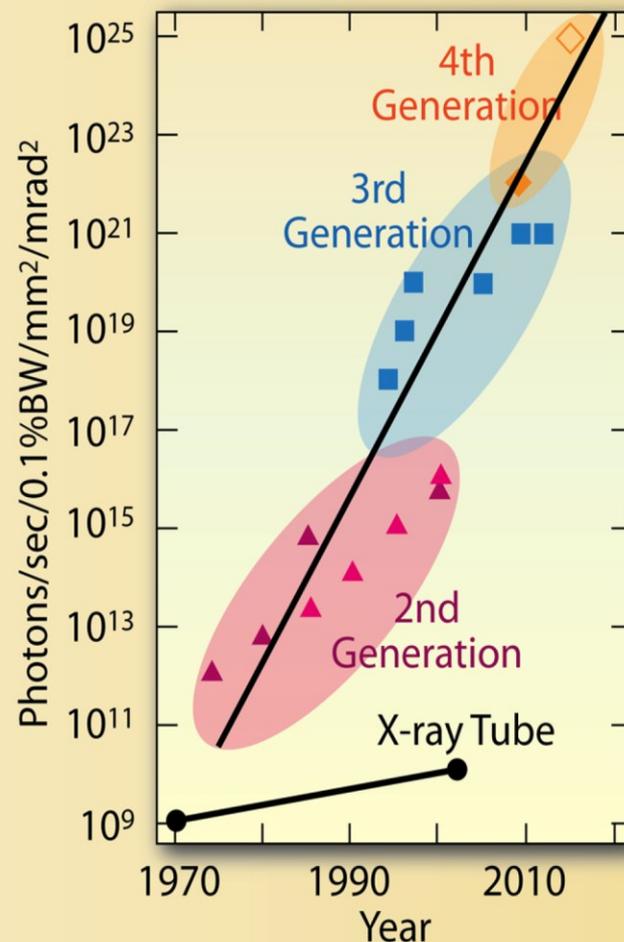
New X-ray/ Neutron Sources Changing the Possible

- **Brilliance figure-of-merit for spatially-resolved exp.**
- **X-ray brilliance doubling faster than Moore's law**
- **SNS with 10x brilliance 100x more efficient detectors**



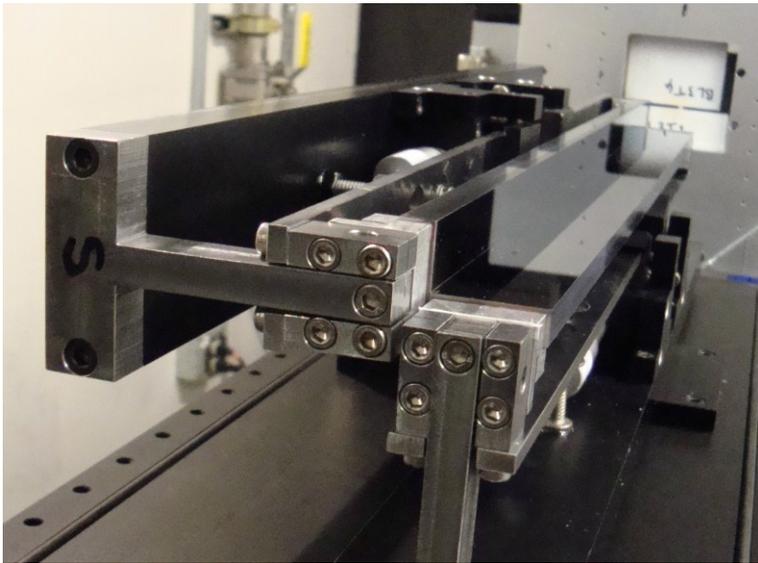
TOPAZ/ SNS

A. Time-average 10 keV X-ray Brilliance

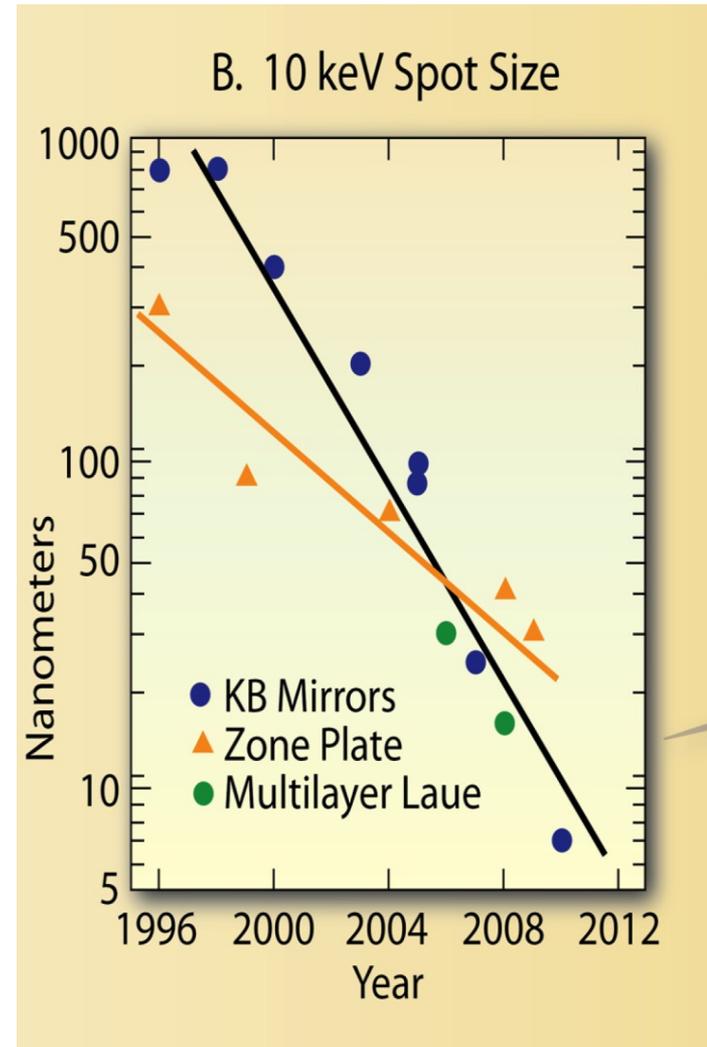


Spatial Resolving Optics Improving Rapidly

- X-ray focal spot size routinely below 100 nm
- Neutron focusing optics below 100 μm

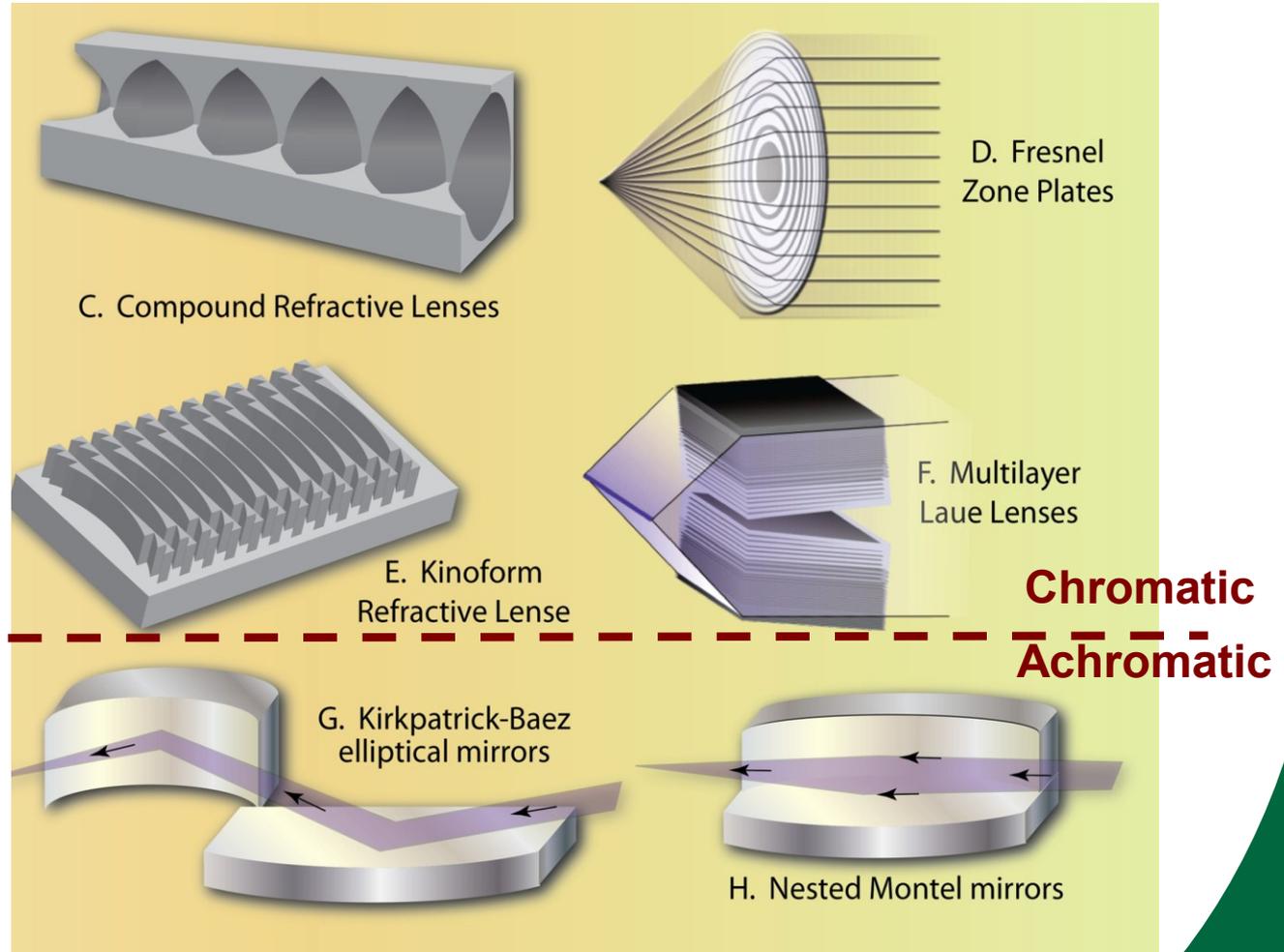


Neutron optics with $<70 \mu\text{m}$ Focus



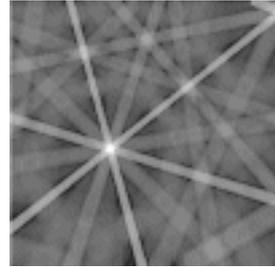
X-ray micro/nanofocusing optics rapidly evolving

- CRL-50 nm
- FZP<30 nm
- Kinoform <70 nm
- MLL <15 nm
- KB <7 nm
- NMM<80 nm

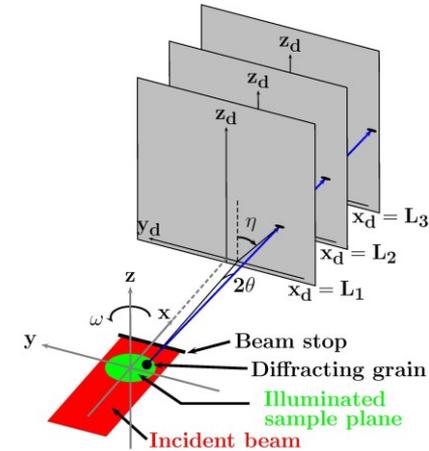


Diffraction mapping emerging area in electron and x-ray microscopy

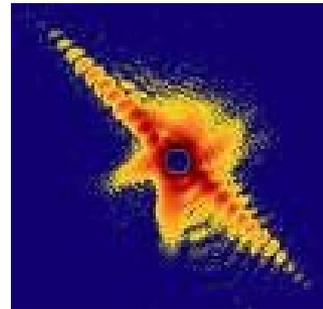
- EBSD-transformed study of polycrystals
 - Surface phase
 - Surface orientation
 - FiB-3D mesoscale structure



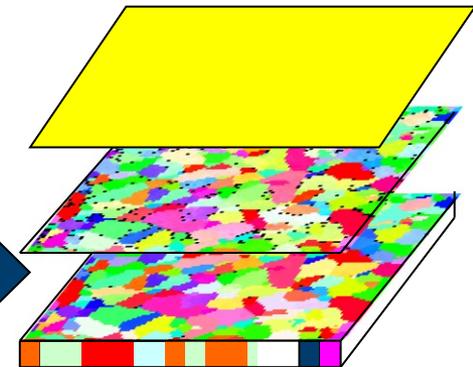
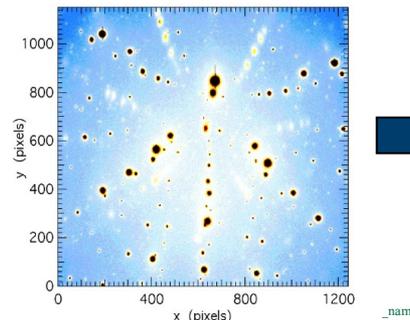
- 4D X-ray microscopy Lienert et al.
 - Time resolved
 - Deep penetration



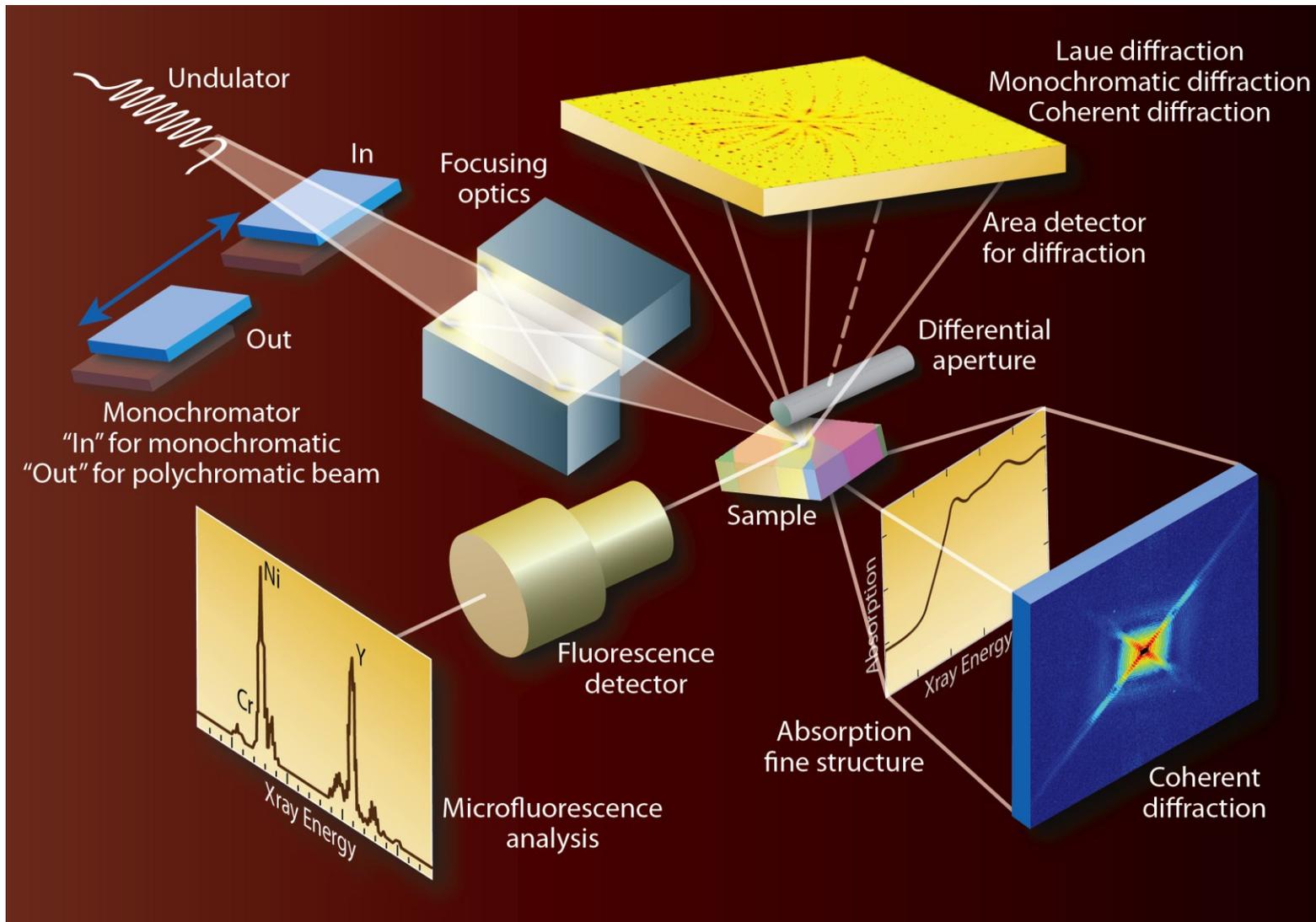
- Coherent X-ray Diffraction (Robinson et al.)
 - Simple structures



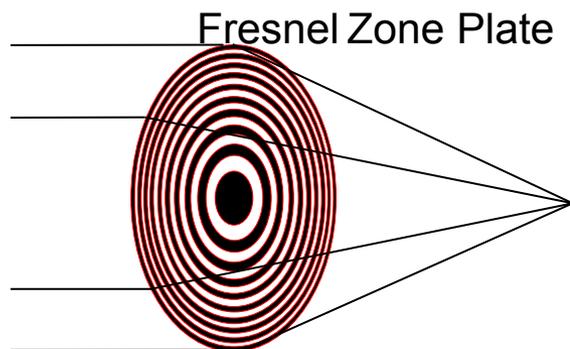
- Polychromatic X-ray microdiffraction
 - Phase/texture/**strain**
 - **Nondestructive**
 - **Submicron**



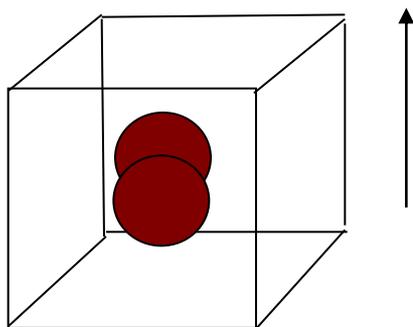
X-ray Micro/nanoprobe beams map chemistry and structure



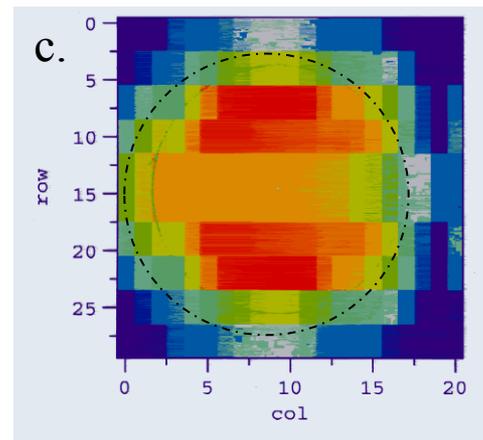
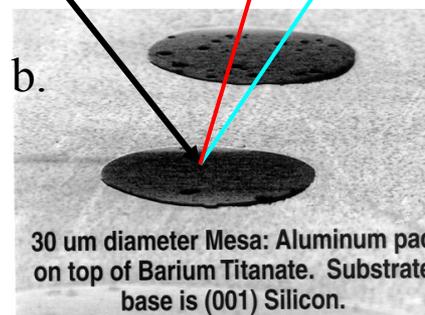
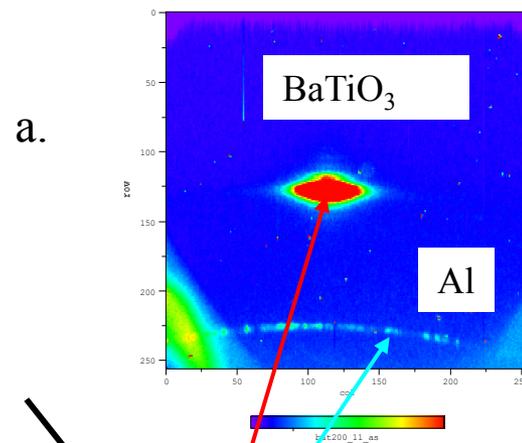
Monochromatic micro crystallography probes simple crystal systems



Wide-range of focusing choices

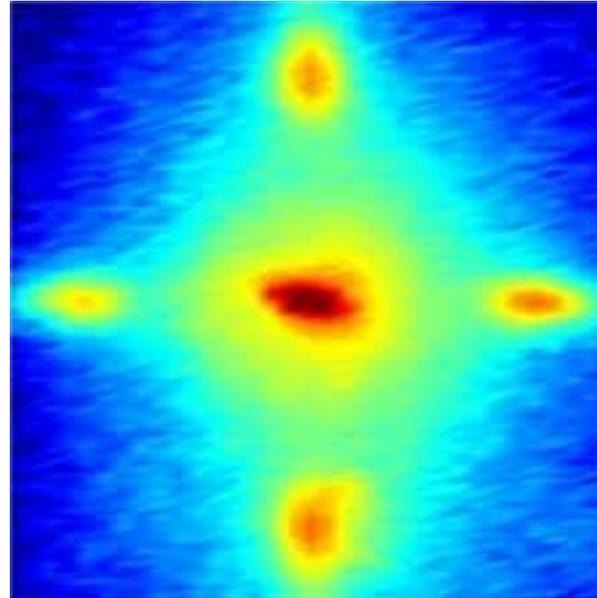


Ferroelectrics ideal samples



Thompson et al. study dimensionality of ferroelectricity

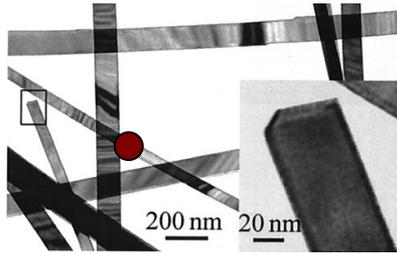
- Thickness
- Ribbons
- Dynamics



Diffraction from a ferroelectric stripe

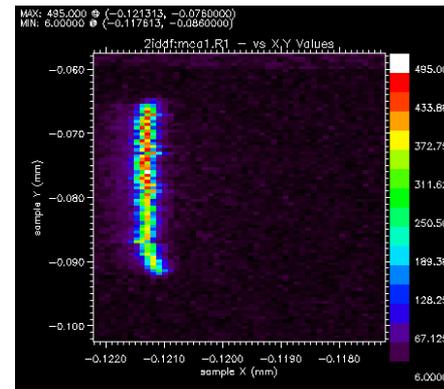
Ferroelectricity found with few unit cells

Cai et al. and others study ultra-small nanocrystalline volumes with existing microbeams

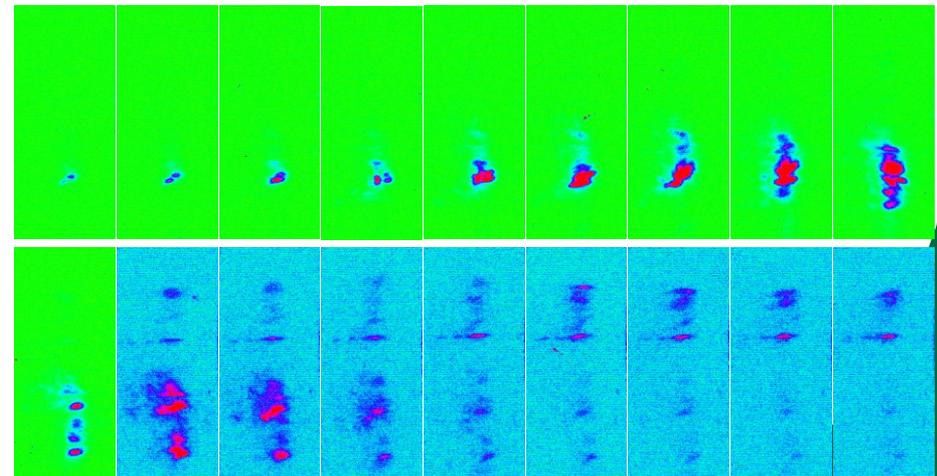
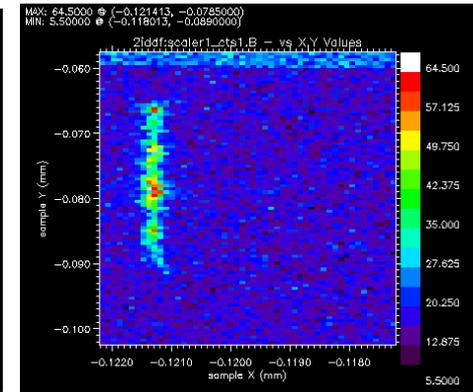


•150 nm beam resolves crystalline substructure in individual Sn_2O_3 nanobelts

Fluorescence map



Diffraction map



APS Nanoprobe- opens new opportunities for spatially resolved

- Diffraction proposals compelling
- Physics of small
- Integrated circuit materials



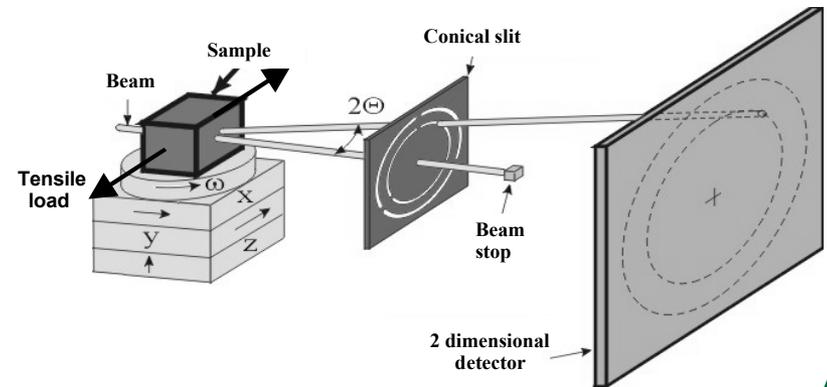
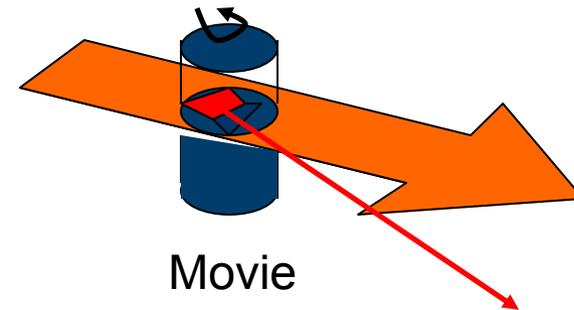
~30 nm now

<10 nm possible in future

NSLSII ~1 nm!

4DXRD Microscope emerging tool for studying mesoscale dynamics-single rotations

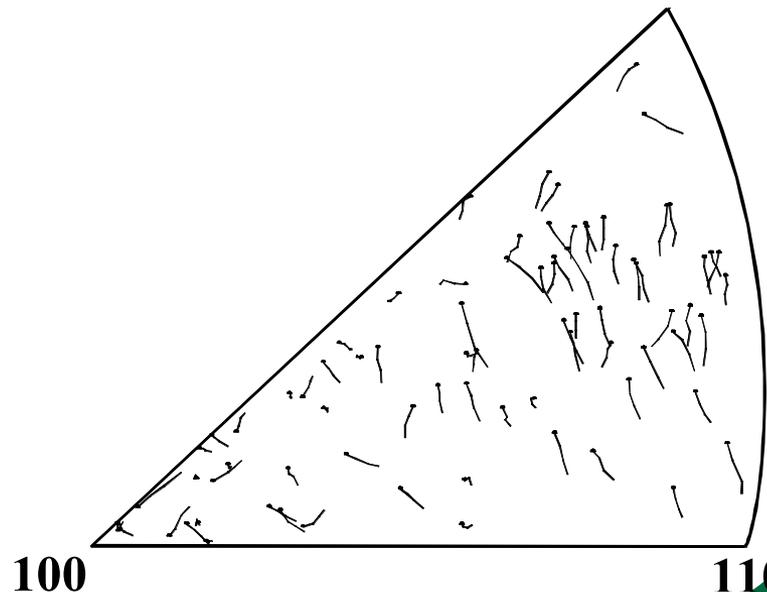
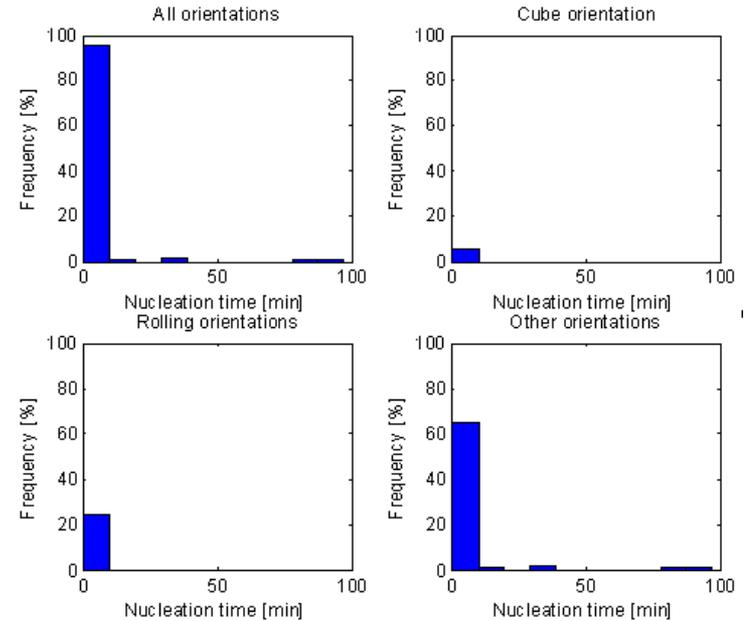
- Singly focused monobeam illuminates numerous grains
 - Bragg condition satisfied by single rotation
 - *Time resolution! (4D)*
- Grain outline determined
 - Ray tracing
 - conical slit
 - Back-projection tomography
- $E > 50$ keV allows deep measurements



Best with high-energy beams/Beamline 1 at APS

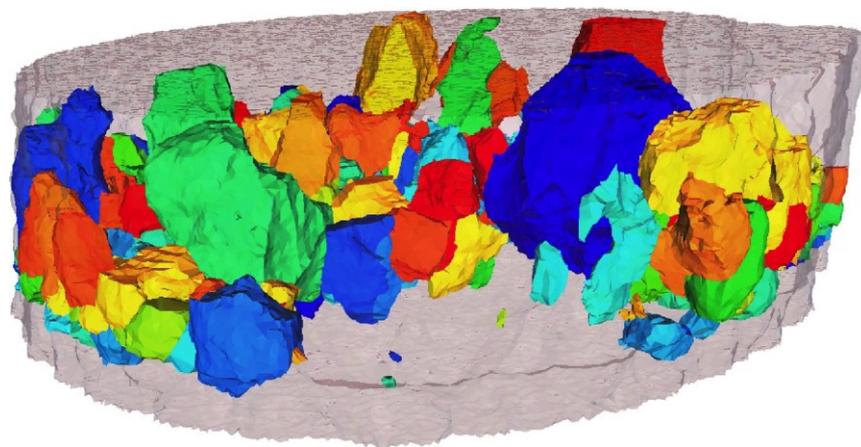
4DXRD Microscope powerful dynamics probe

- **Recrystallization growth individual grains-deep**
 - E. M. Lauridsen, D. Juul Jensen, U. Lienert and H.F. Poulsen (2000). *Scripta Mater.*, 43, 561-566
- **Rotations/texture evolution individual grains during deformation**
 - Tests deformation models
 - L. Margulies, G. Winther and H.F. Poulsen, *Science* 291, 2392-2394 (2001).



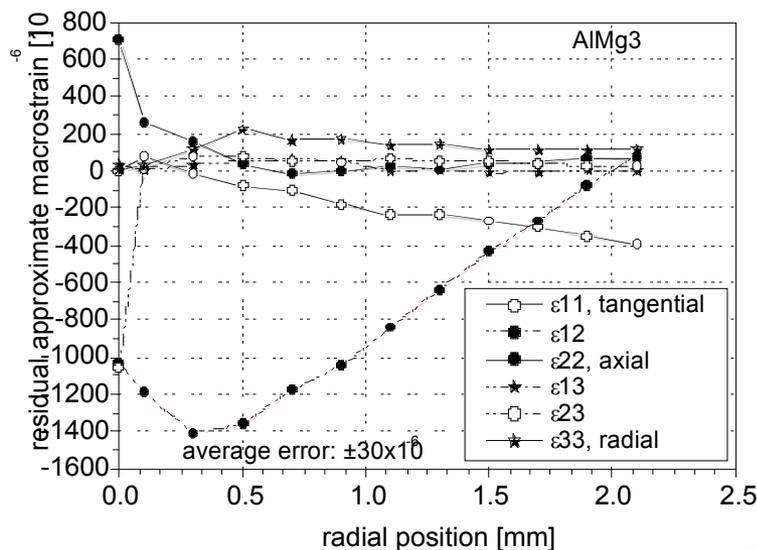
4DXRD Microscope provides additional powerful capabilities

- Grain boundary mapping in coarse grained materials-5 μm
 - Poulsen et al. J. Appl. Cryst. 34 751-756 (2001)



- Single crystal refinement for polycrystals

- Macro/microstrain



Ideal for neutrons! But needs high-resolution detectors!

Strain tensor elements in torsion sample

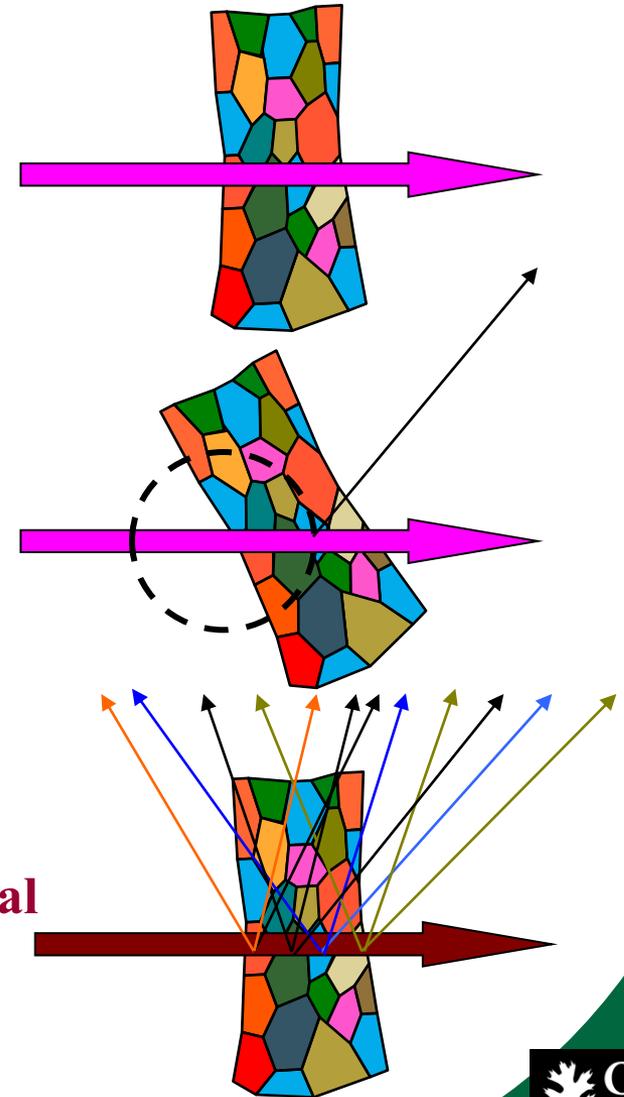
Polychromatic simplifies microdiffraction

Solves intrinsic problem with conventional microdiffraction-

-Sample does not need to be rotated!

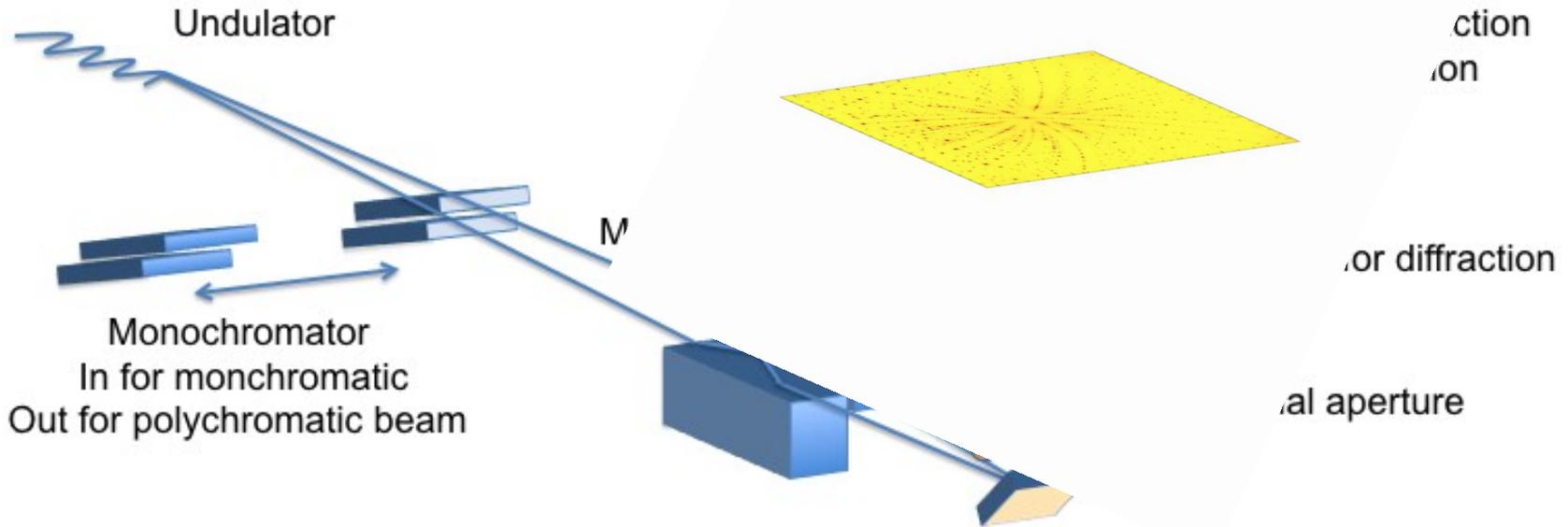
Special software required- Can index polycrystalline samples

3D nondestructive probe of stress/strain/crystal structure!

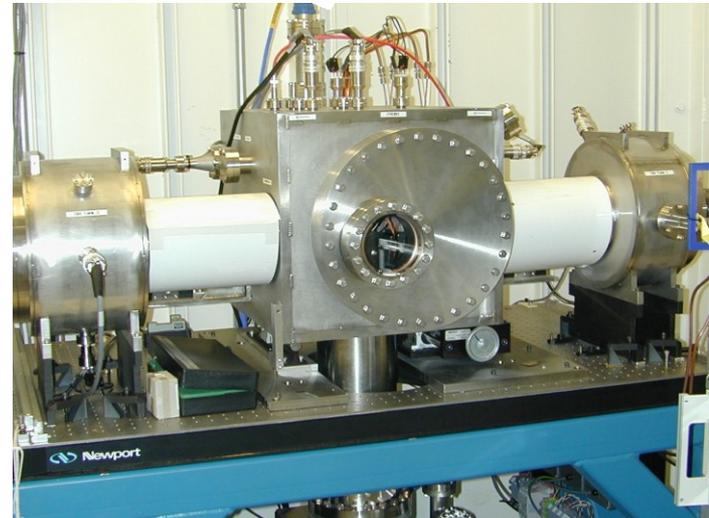
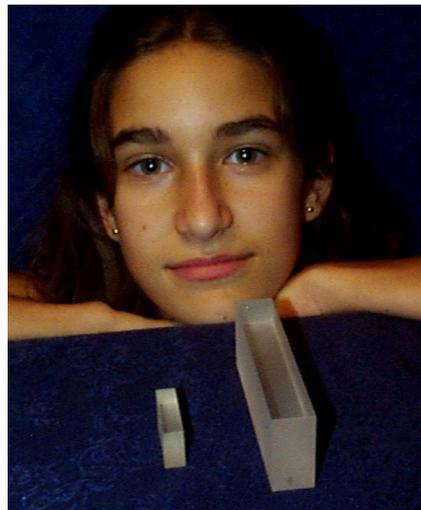


3-D X-ray Crystal Microelements

Specialized

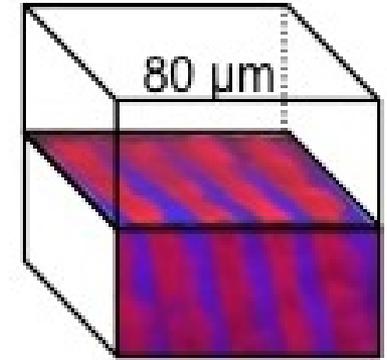
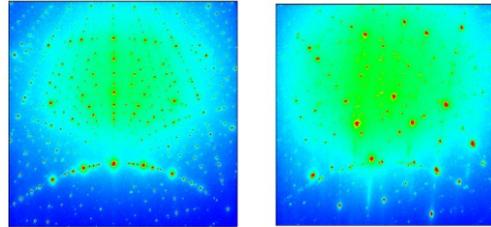


$<0.25 \times 0.25 \times 0.5 \mu\text{m}^3$
strain $\sim 10^{-4} - 10^{-5}$

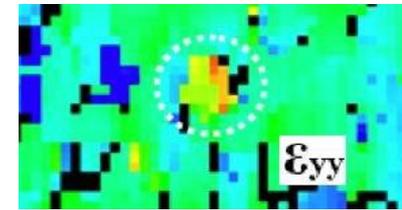
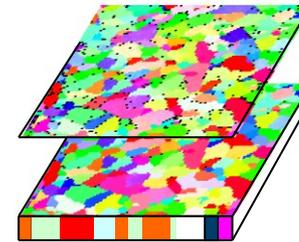
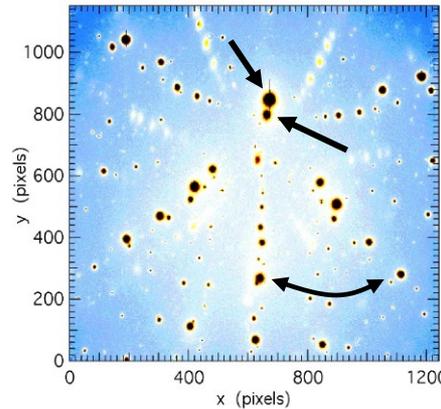


Provides Submicron 3D Maps With New Information

- Phase boundaries

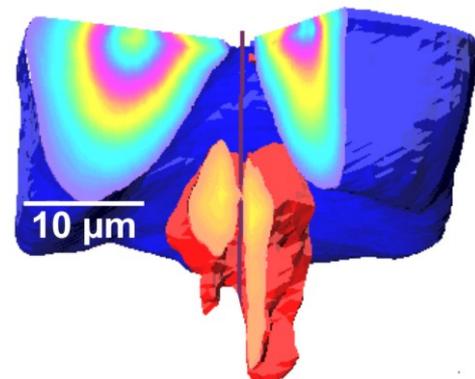
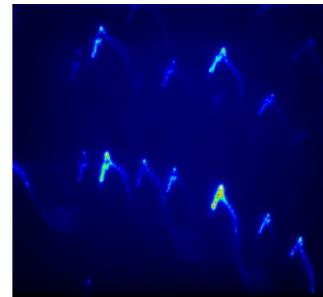


- Grain boundaries (3D)



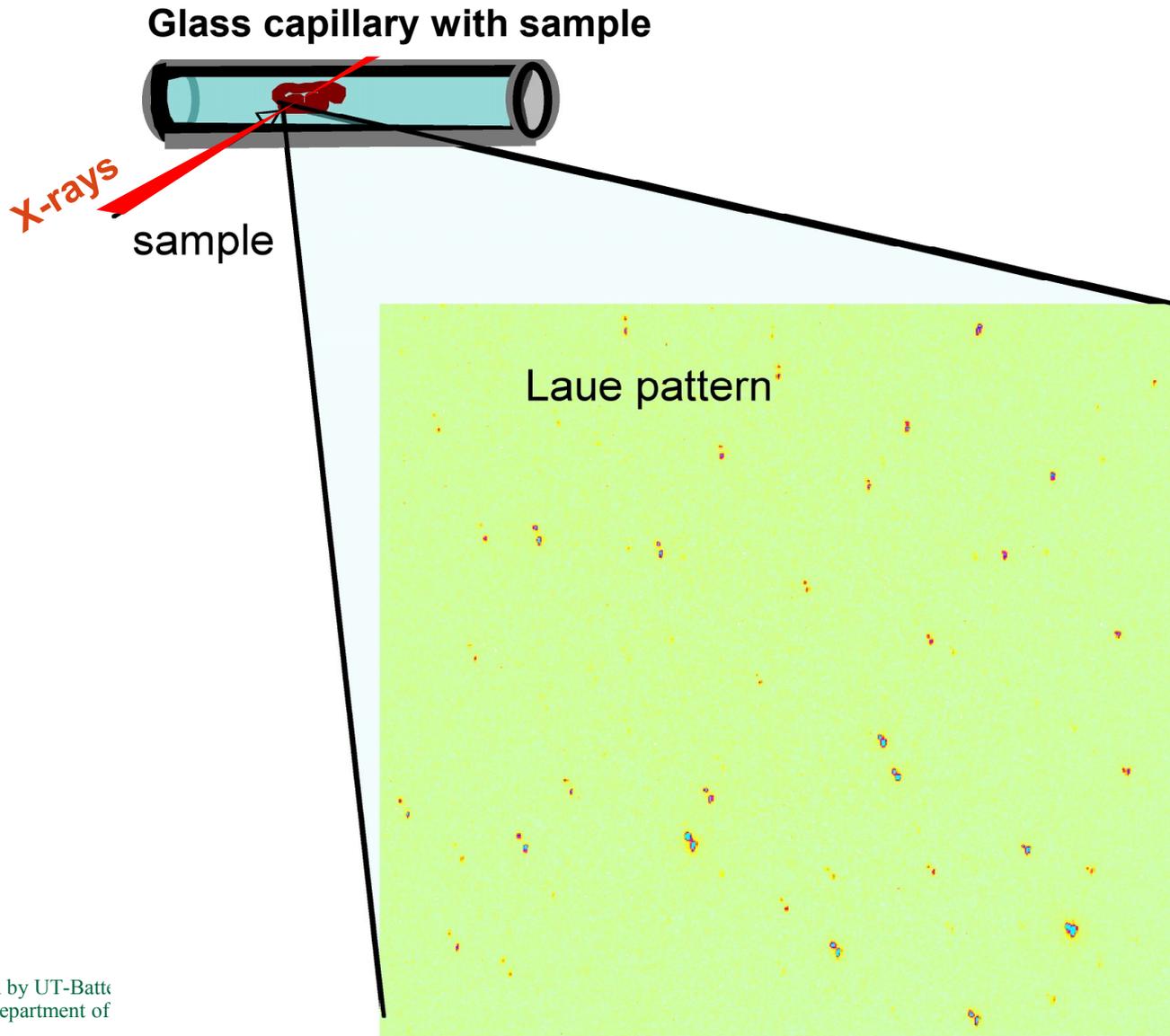
- Elastic strain

- Deformation /Nye tensor



Nondestructive!

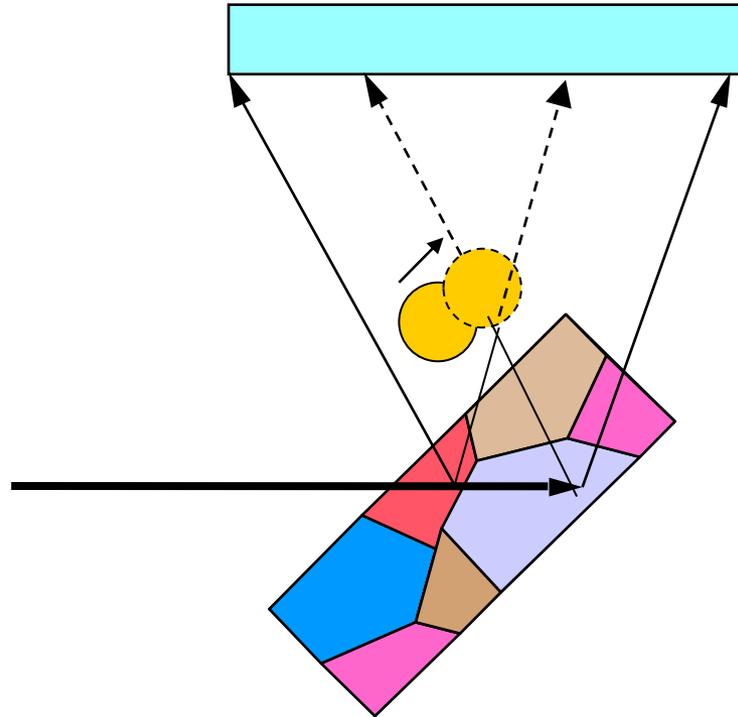
Laue methods essential for some samples



Differential aperture microscopy resolves submicron along incident beam!

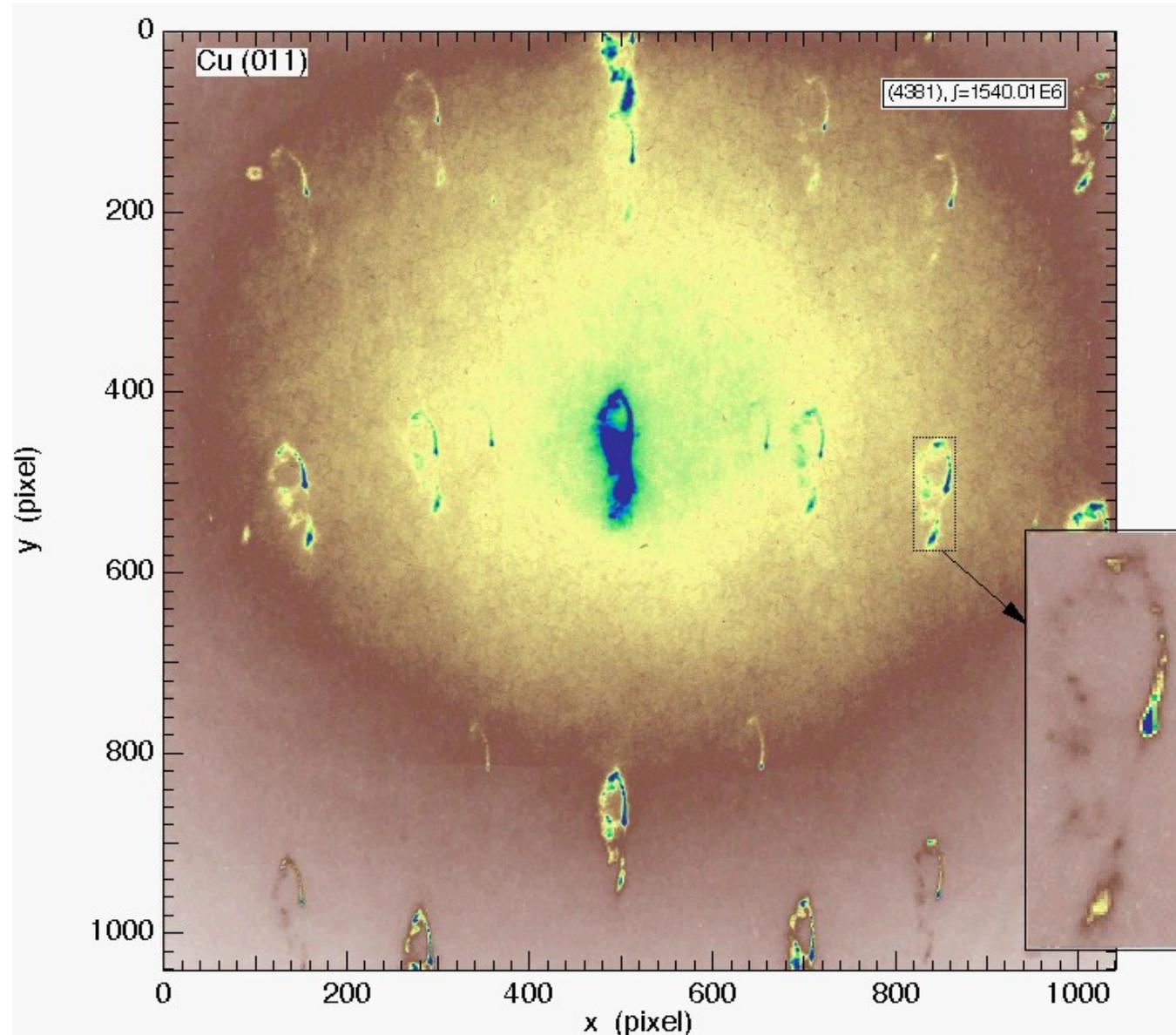


- Simplifies data interpretation
- Submicron Z resolution
- Isolates weak diffraction from strong
- First demonstration by Larson et al. on deformed Cu -

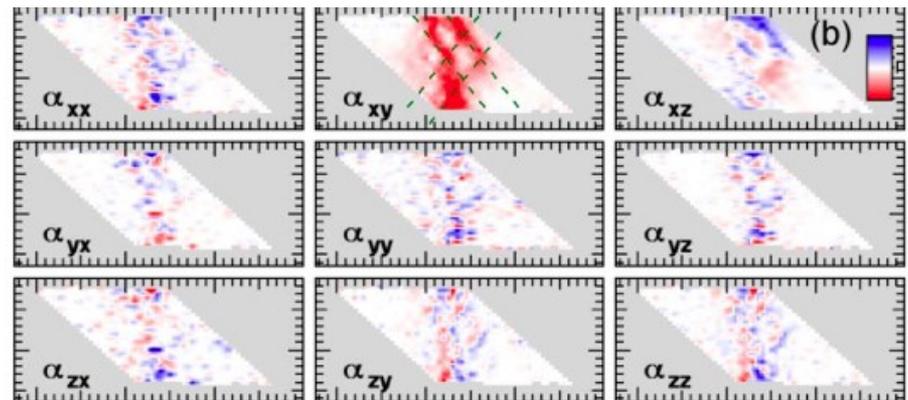
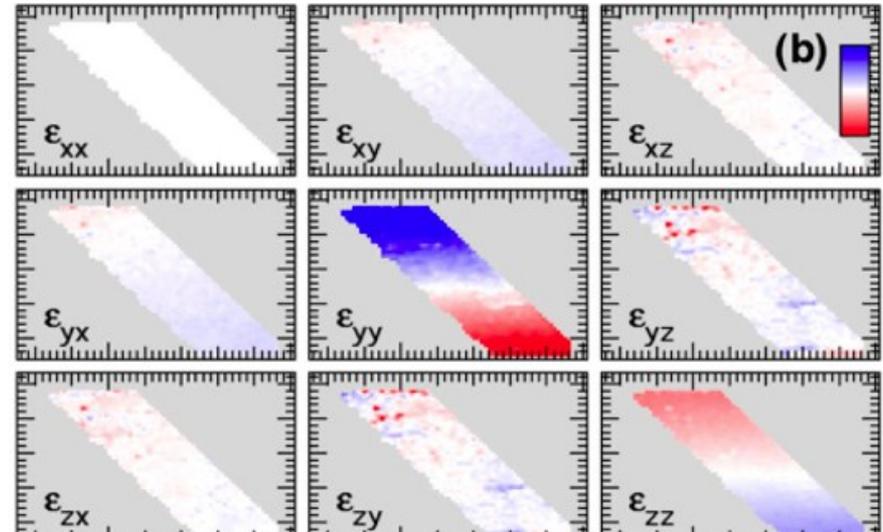
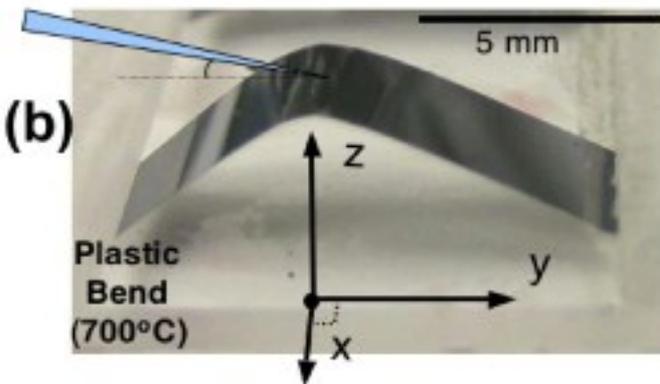
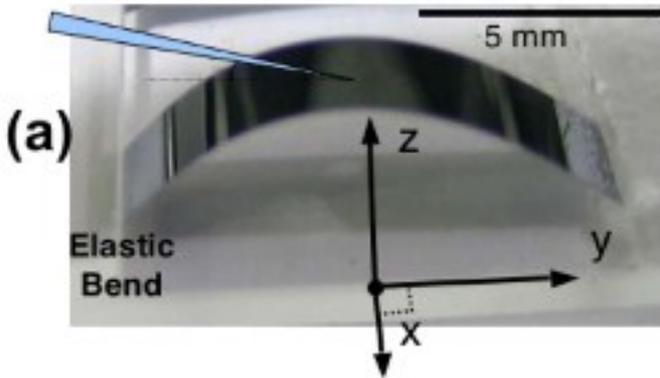


As wire moves its edge cuts through Laue spots

- Near-surface fluorescence provides moving shadow
- Long scans needed for deep penetration



Measurements of elastic strain tensor *inside* bent single crystal Si illustrate power of DAXM

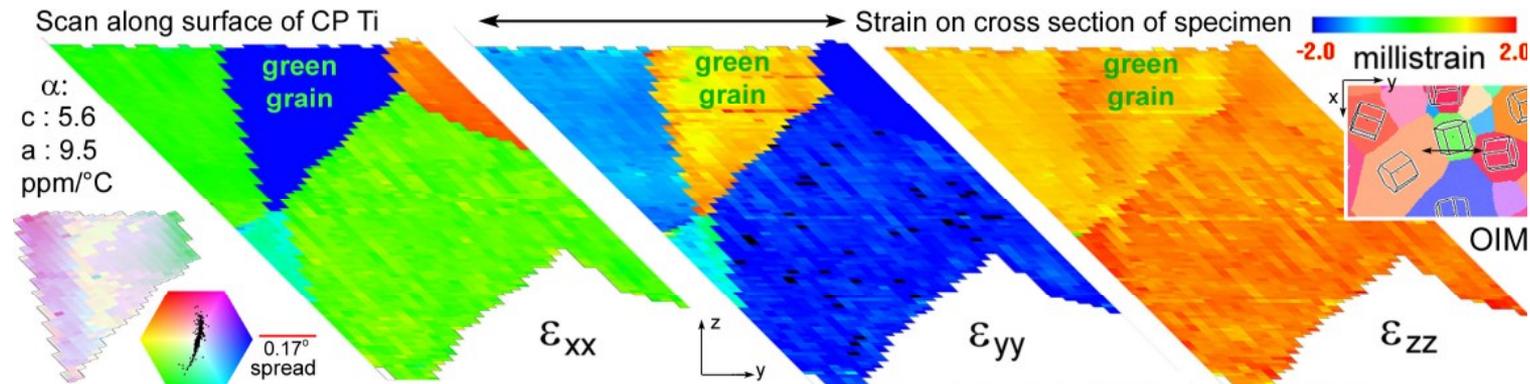
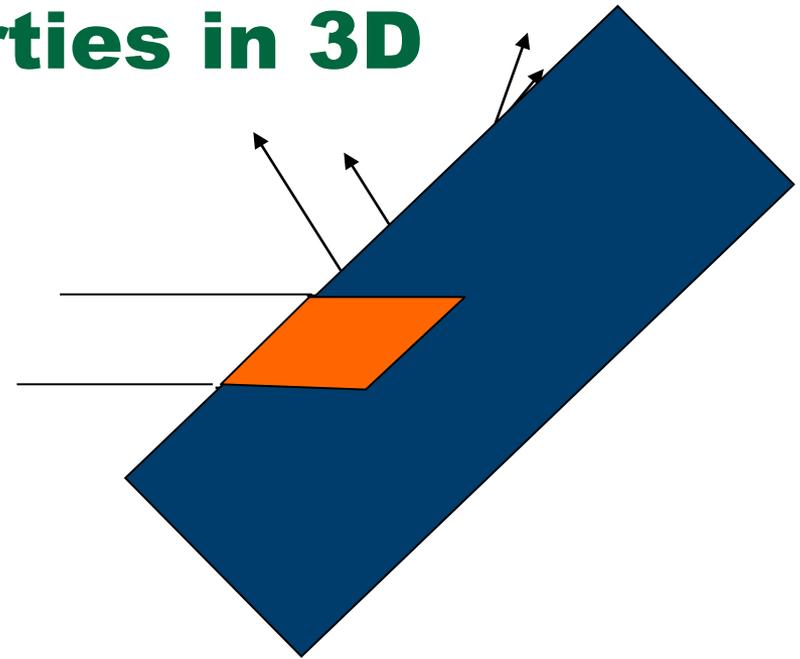


Orientations to 0.001°

Larson et al. J. Eng. Mat. and Tech. 130 021024 (2008) ORR award

Maps crystal properties in 3D

- Phase
- Texture (orientation)
- Elastic strain tensor
- Nye tensor (deformation)



T. Bieler et al.

Experimental Hutch 34ID-E at UNICAT, Advance Photon Source

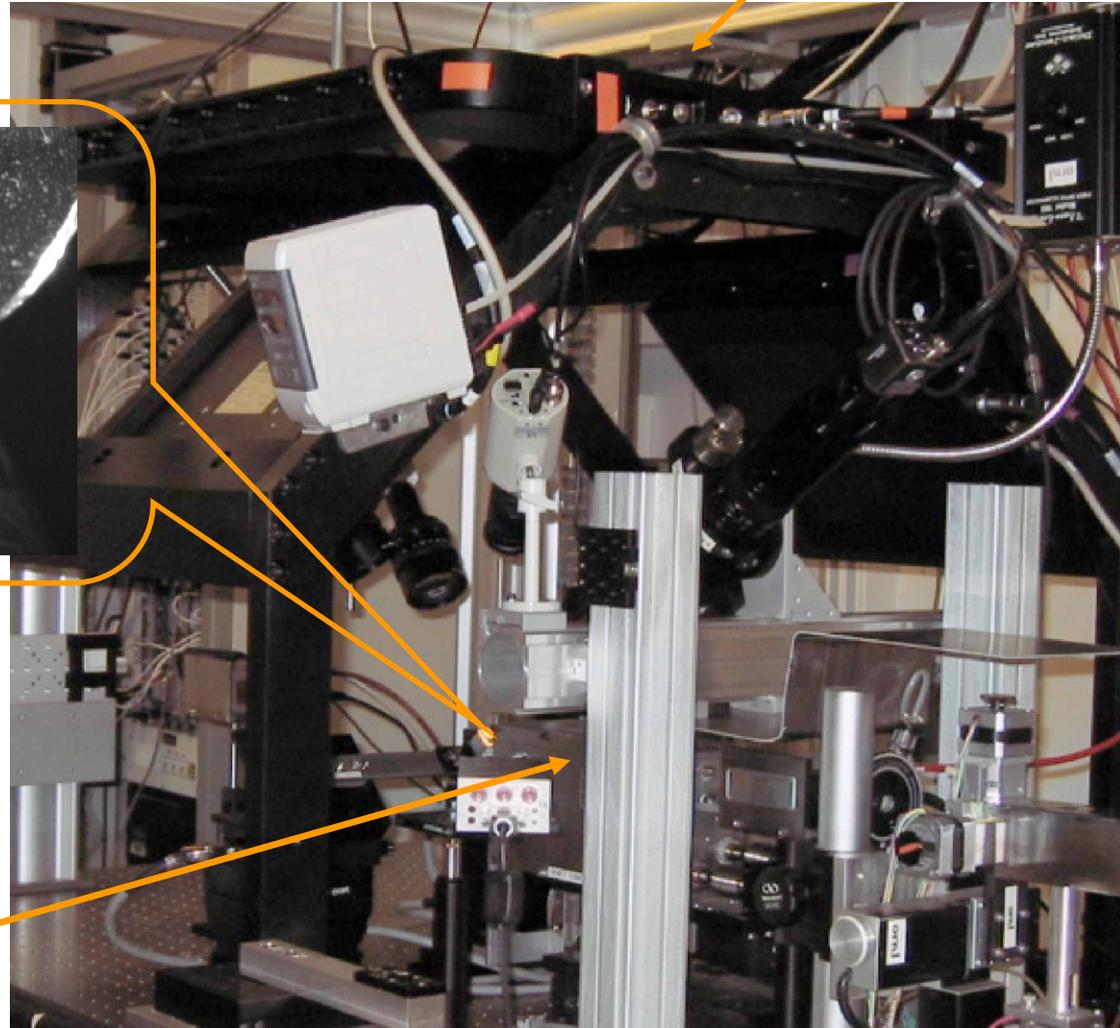
Amorphous Si
Area detector



differential aperture

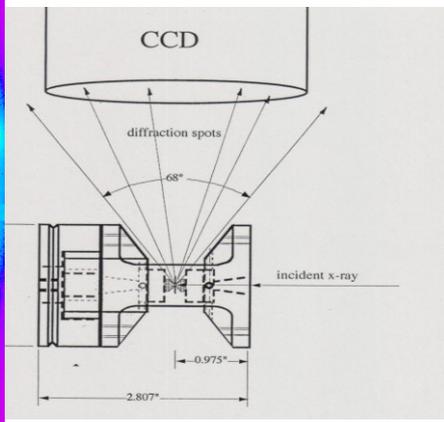
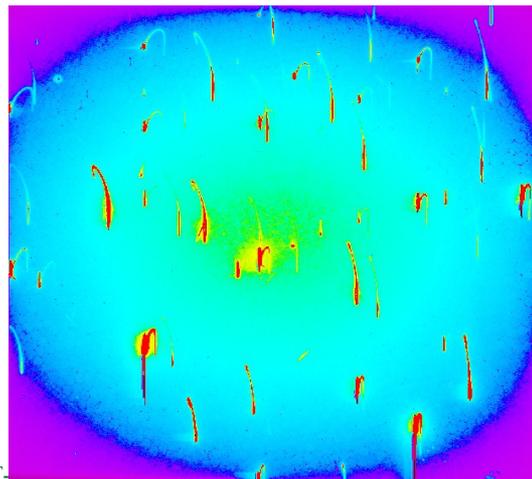
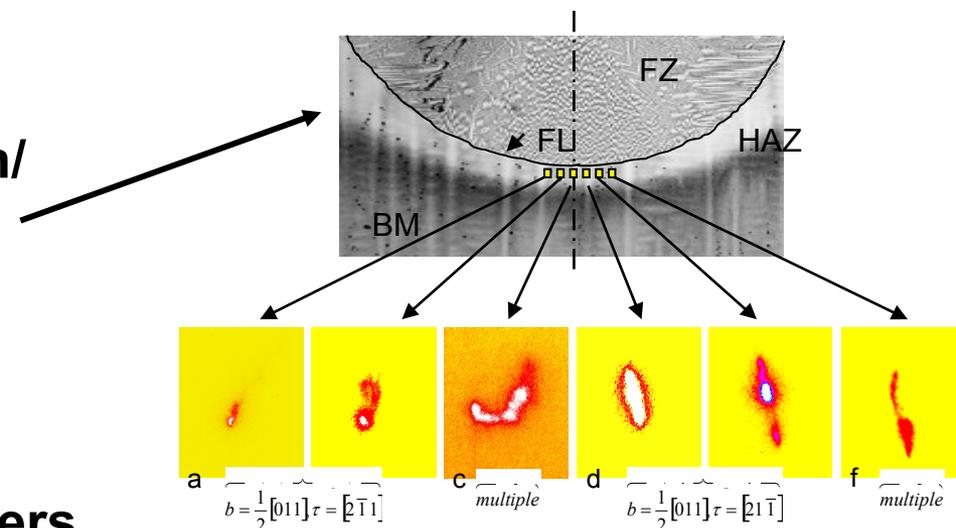
(wire scan, $\sim 200 \mu\text{m}$
above sample surface)

Mirror box



Ongoing research too extensive to cover

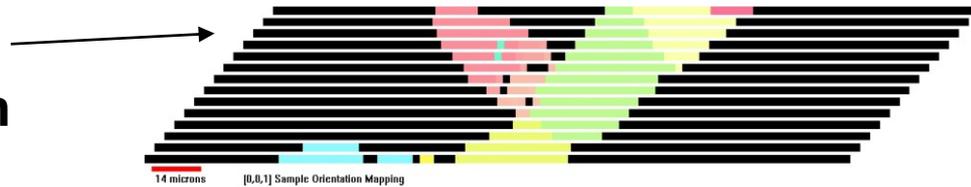
- Fracture/stress localization in thin films
- Residual stresses/ deformation/ grain boundary network near welds
- Complex phase patterned materials
- Extreme environmental chambers



Ongoing too extensive continued..

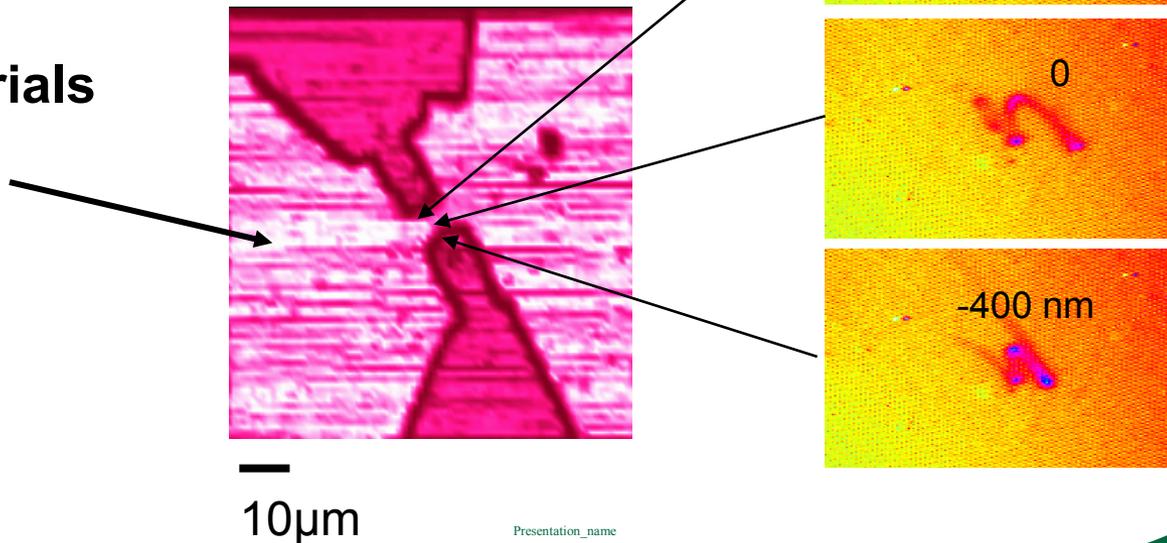
- Domain wall structure measurements

- Sn whisker growth



- High-performance alloys

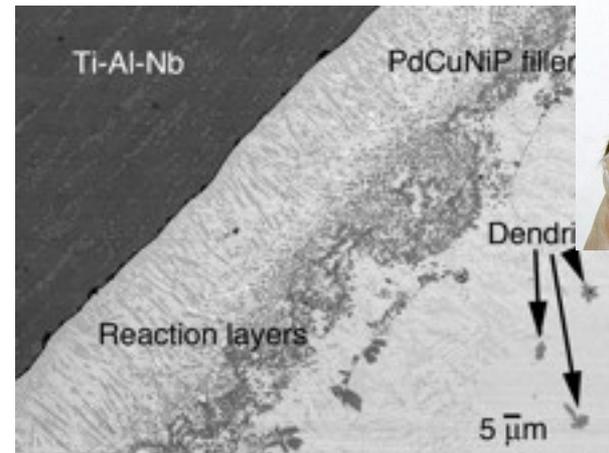
- Nanomaterials



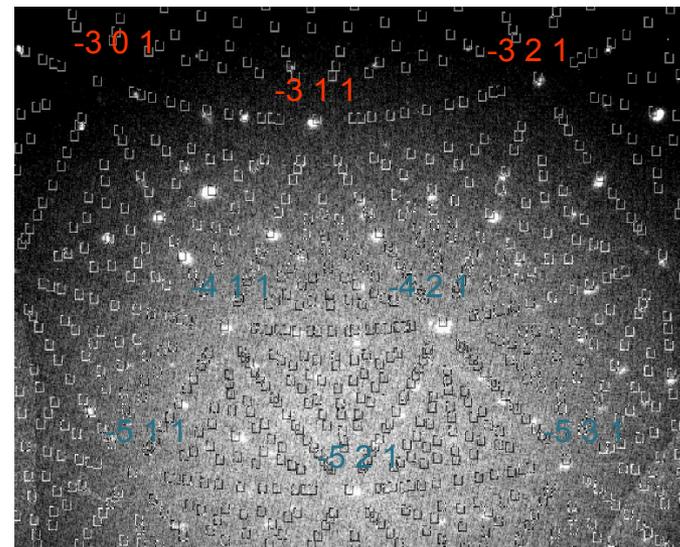
Energy scans allow structure determination

- Generalization of orientation software can identify phases
- Energy scans provide integrated reflectivities.
- Identified two minor crystal phases tetragonal/hexagonal

Cannot be found by powder

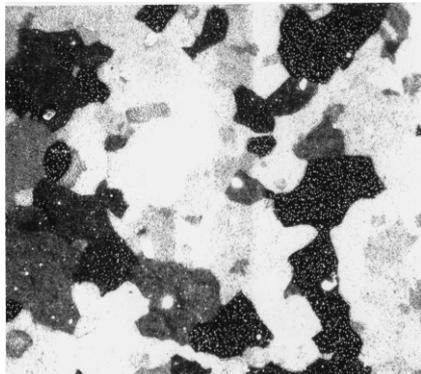


BAM braze $\text{Pd}_{40}\text{Cu}_{30}\text{Ni}_{10}\text{P}_{20}$

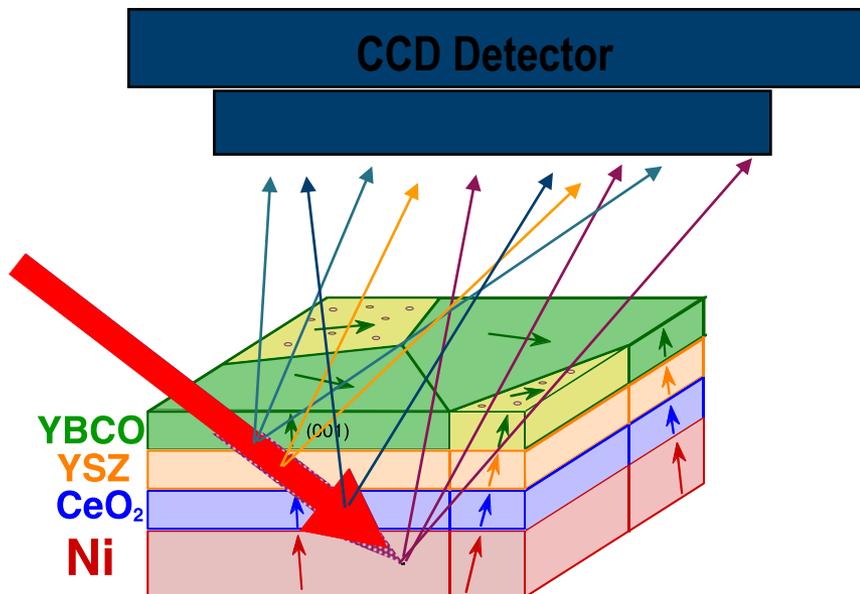
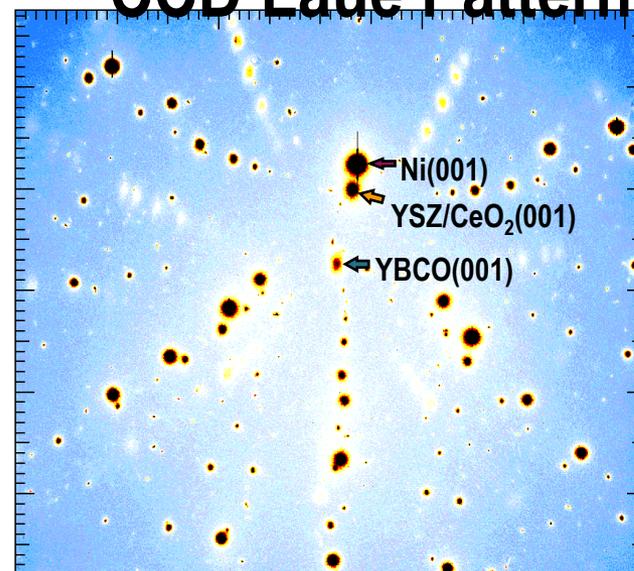


Grain-growth/ Budai et al. characterized epitaxial growth RABiTS

Optical: $\sim 50\mu\text{m}$ grains

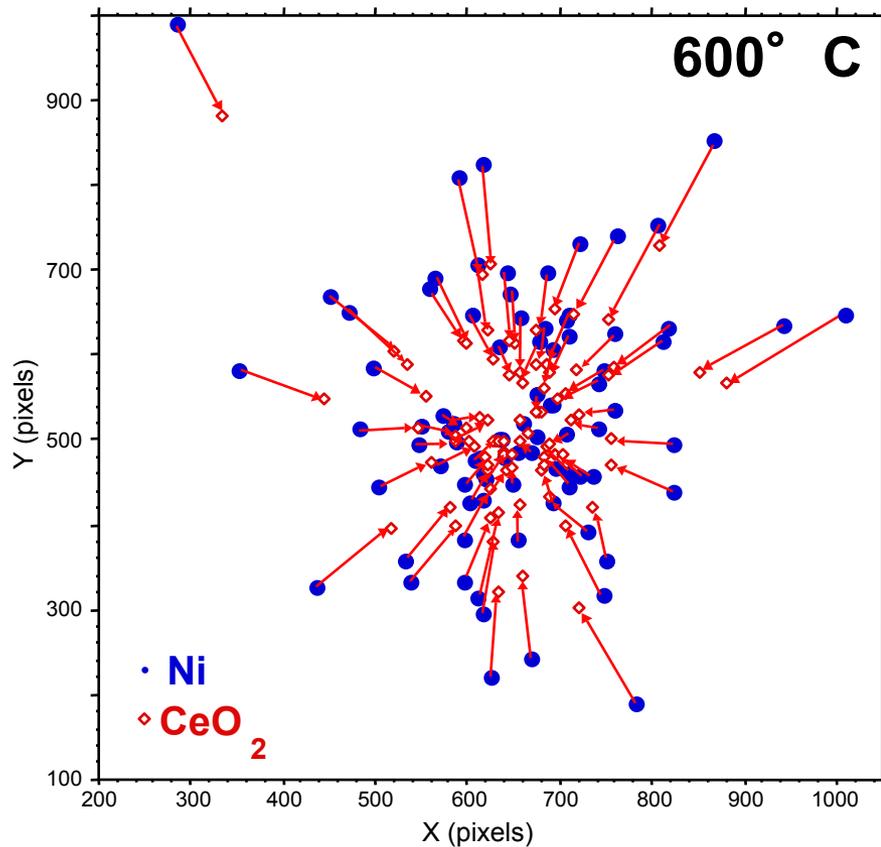


CCD Laue Patterns



CeO₂ Observation:
Exact epitaxy for growth at low T; lattice tilts at high T

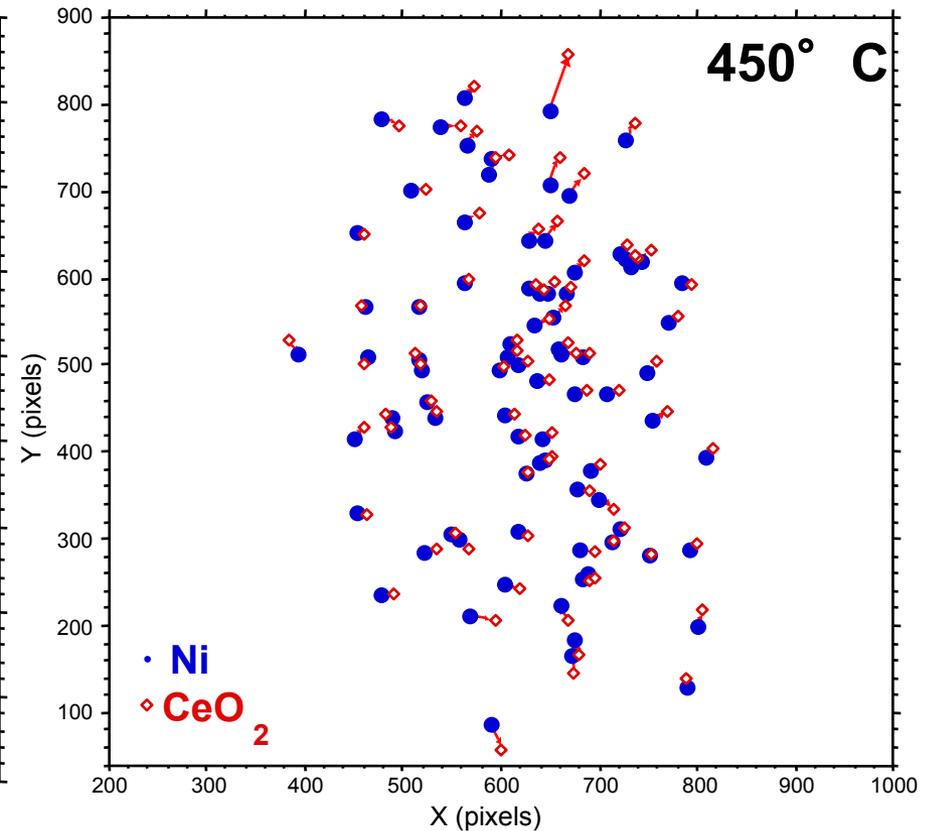
Relative CeO_2 orientation depends deposition temperature



Step edge growth- good:

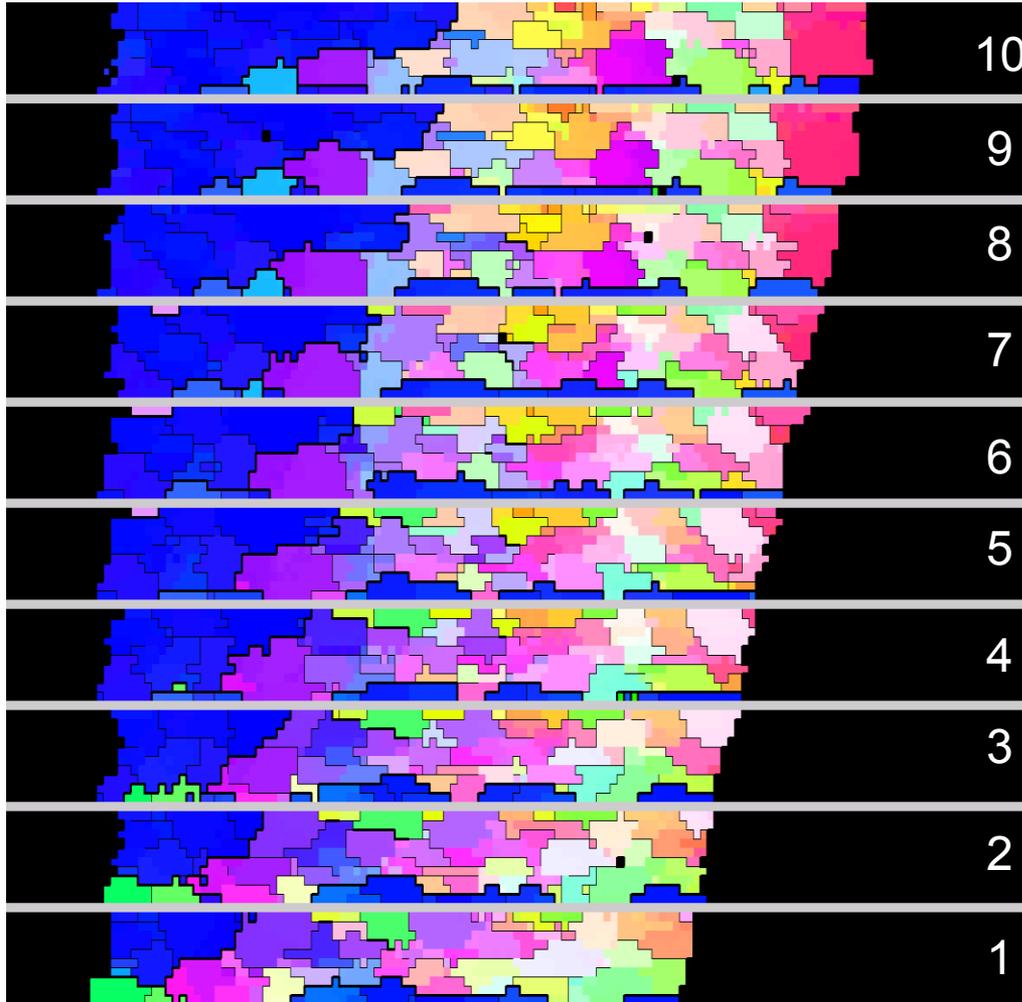
Crystallographic tilt towards \perp

Tilt increases monotonically with miscut

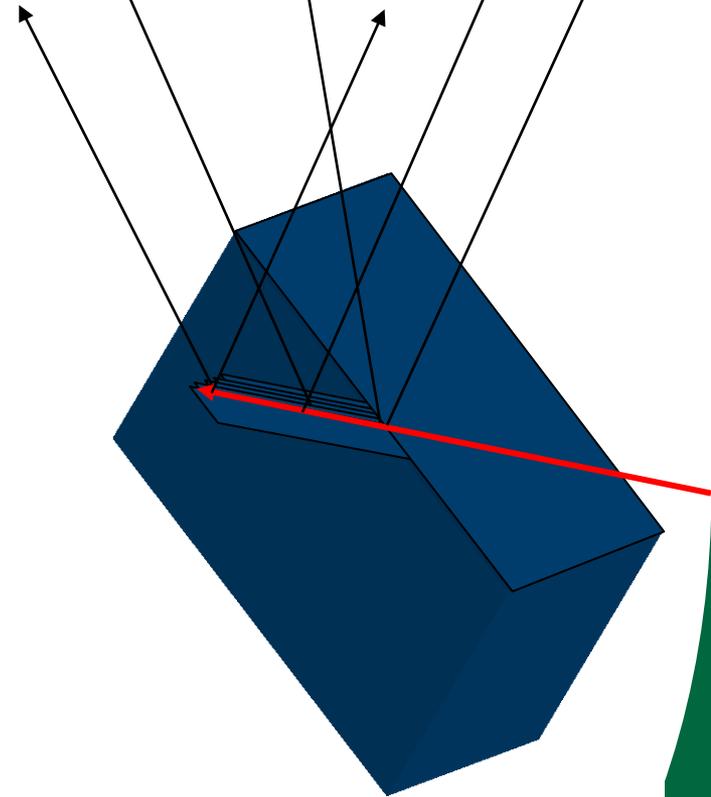


Island growth-bad:

In-situ observations of 3D Grain Growth



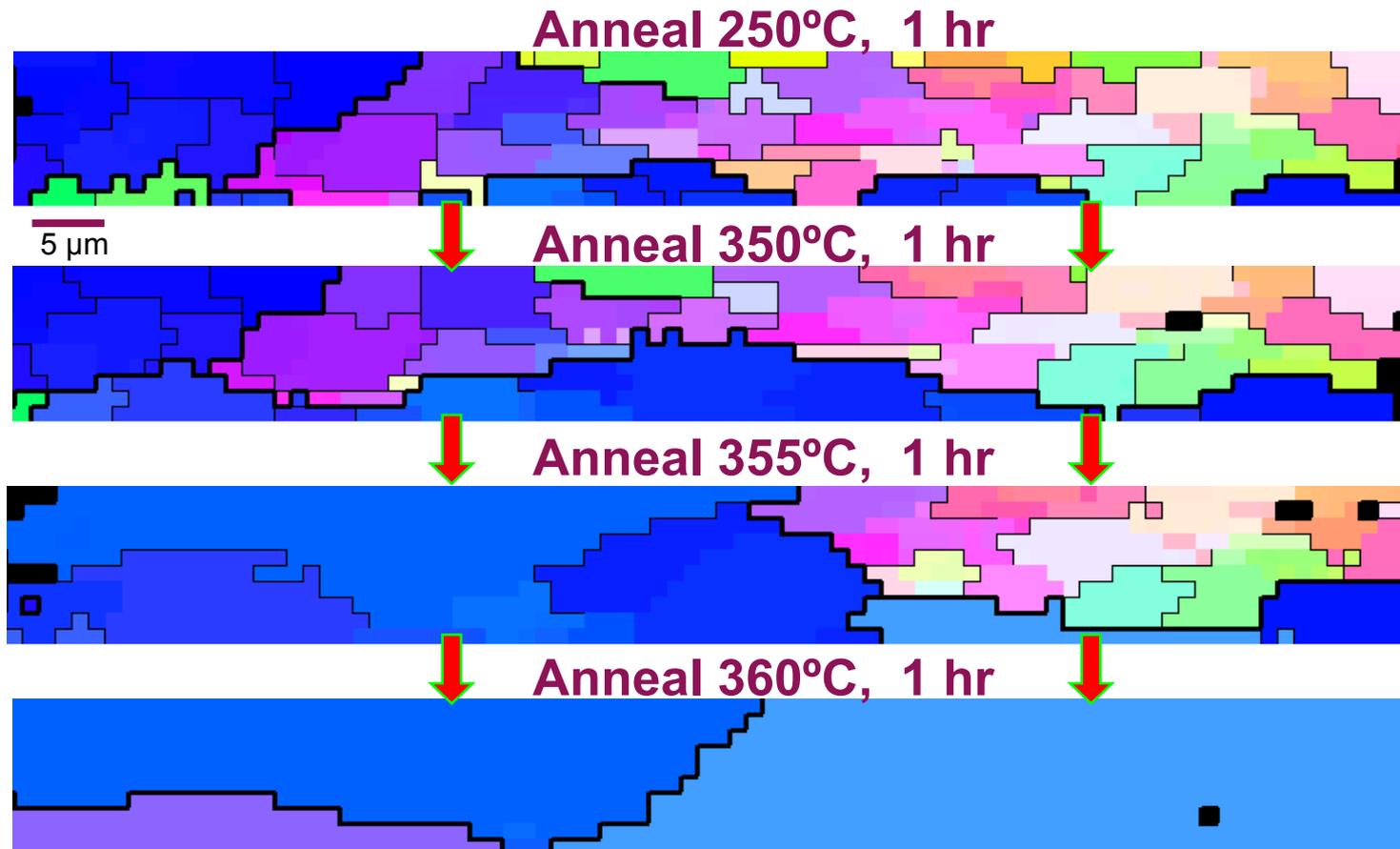
7 microns Tiled [1,1,1] IPF Map Misorientation angle 0.5 to 18.0 degrees



Hot-rolled (200° C
1xxx Al (~1%Fe, Si)
Alcoa Polycrystal

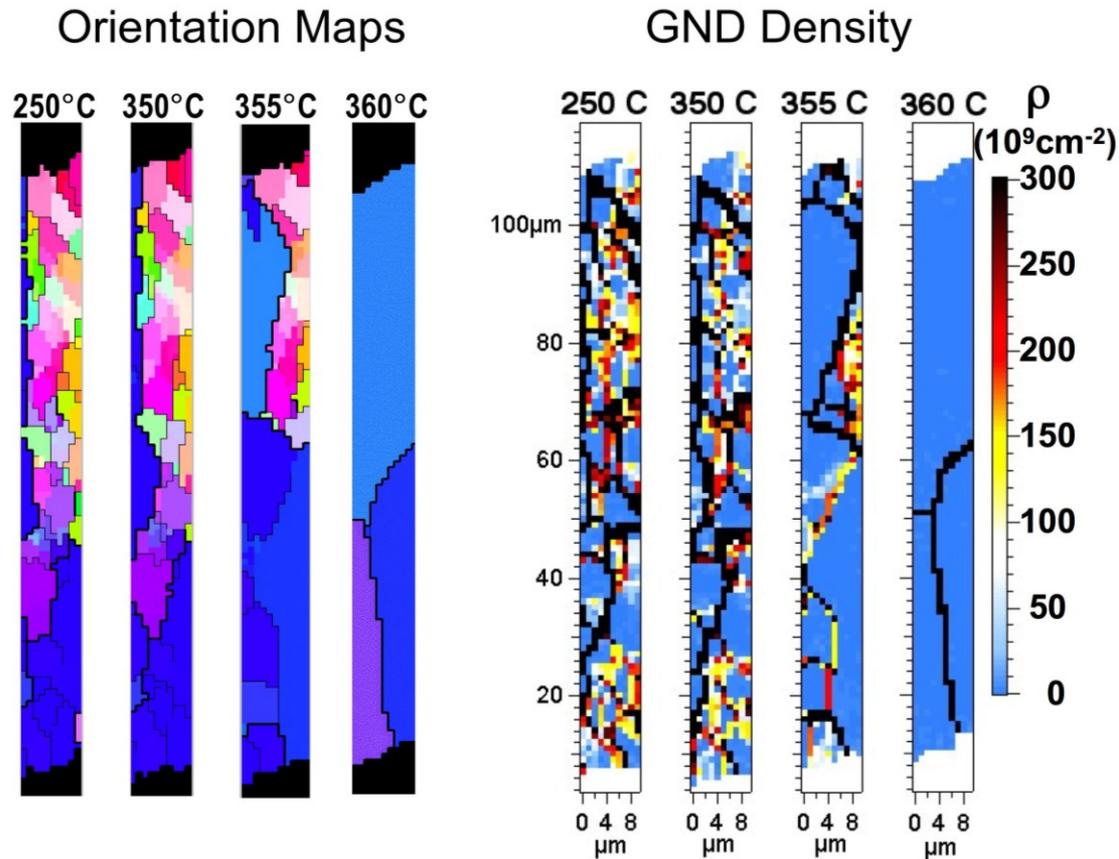
Thermal Grain Growth in Hot-Rolled Aluminum

1 μm pixels, Boundaries: 5° & 20°



- GB motions include both high-angle and low-angle boundaries
- Complete and detailed 3D evolution needed for validation of theories.

Thermal Grain-Growth And Microstructure Refinement in Polycrystalline Al



- 3D X-ray Microscopy Measurements of Dislocation Density Finds Microstructure Refinement to Be Important

Deformation mediated by “dislocations”

- Individual dislocations can be seen with TEM-but...

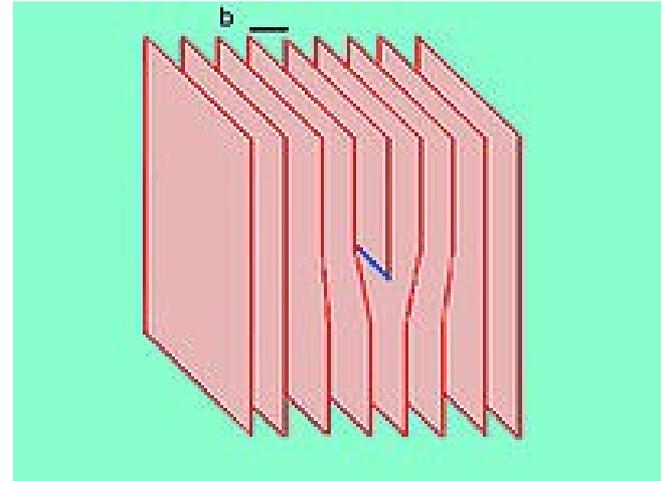


**X-ray people complain
thin electron samples
Fundamentally different**

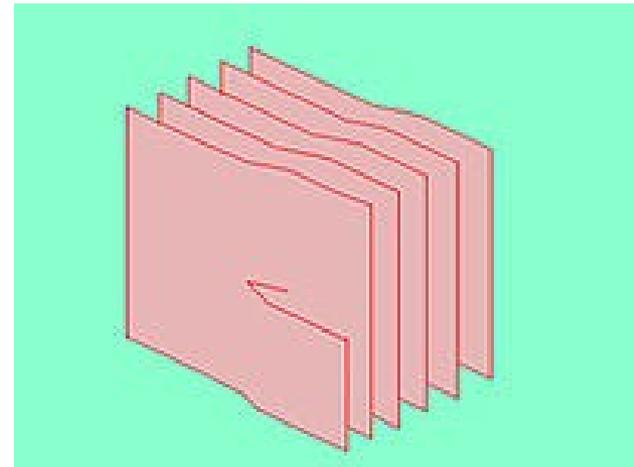


**Neutron people complain
thin X-ray samples
Fundamentally different**

What is “thin” and “bulk”?



Edge dislocation

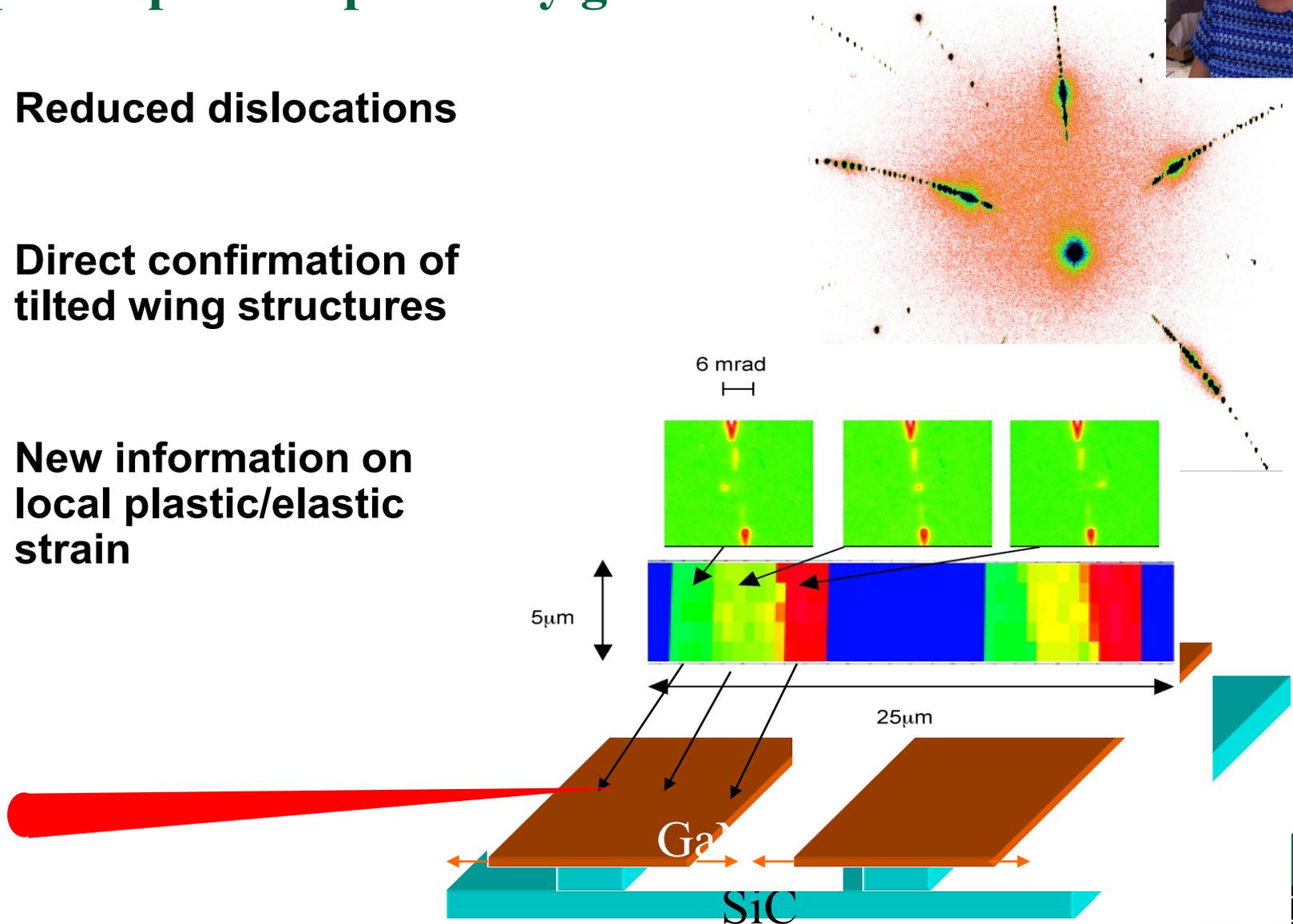


Screw Dislocation

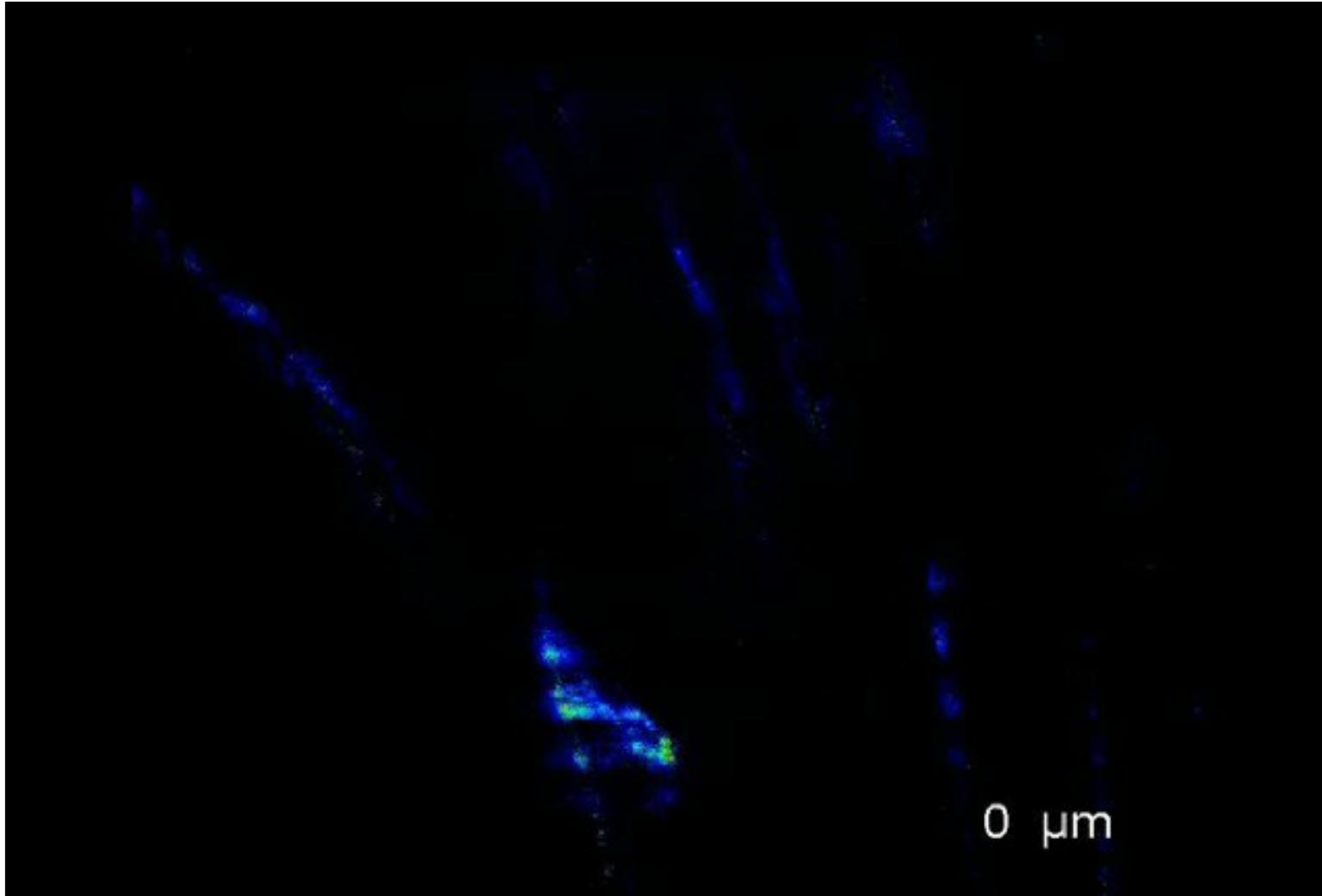


Local orientation and plastic/elastic deformation mapped in pendeoepitaxially grown GaN

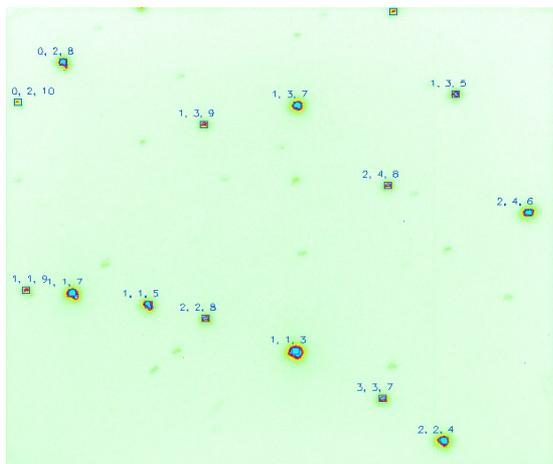
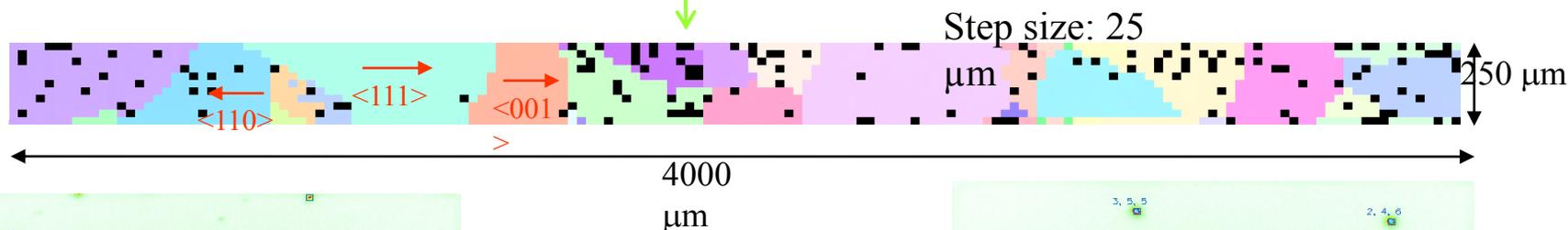
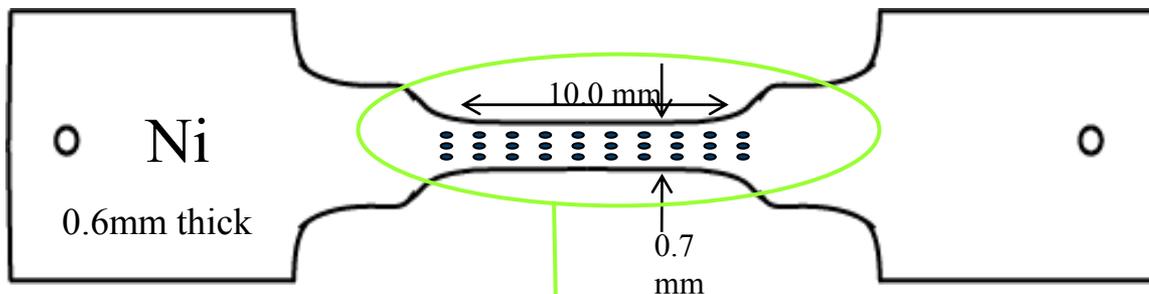
- Reduced dislocations
- Direct confirmation of tilted wing structures
- New information on local plastic/elastic strain



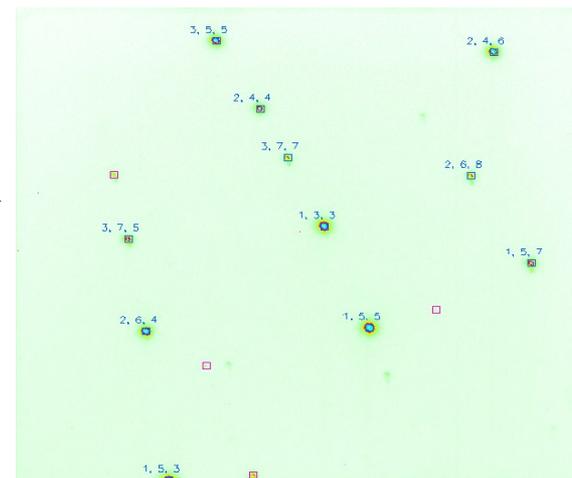
Deformation typically larger near surfaces/grain boundaries



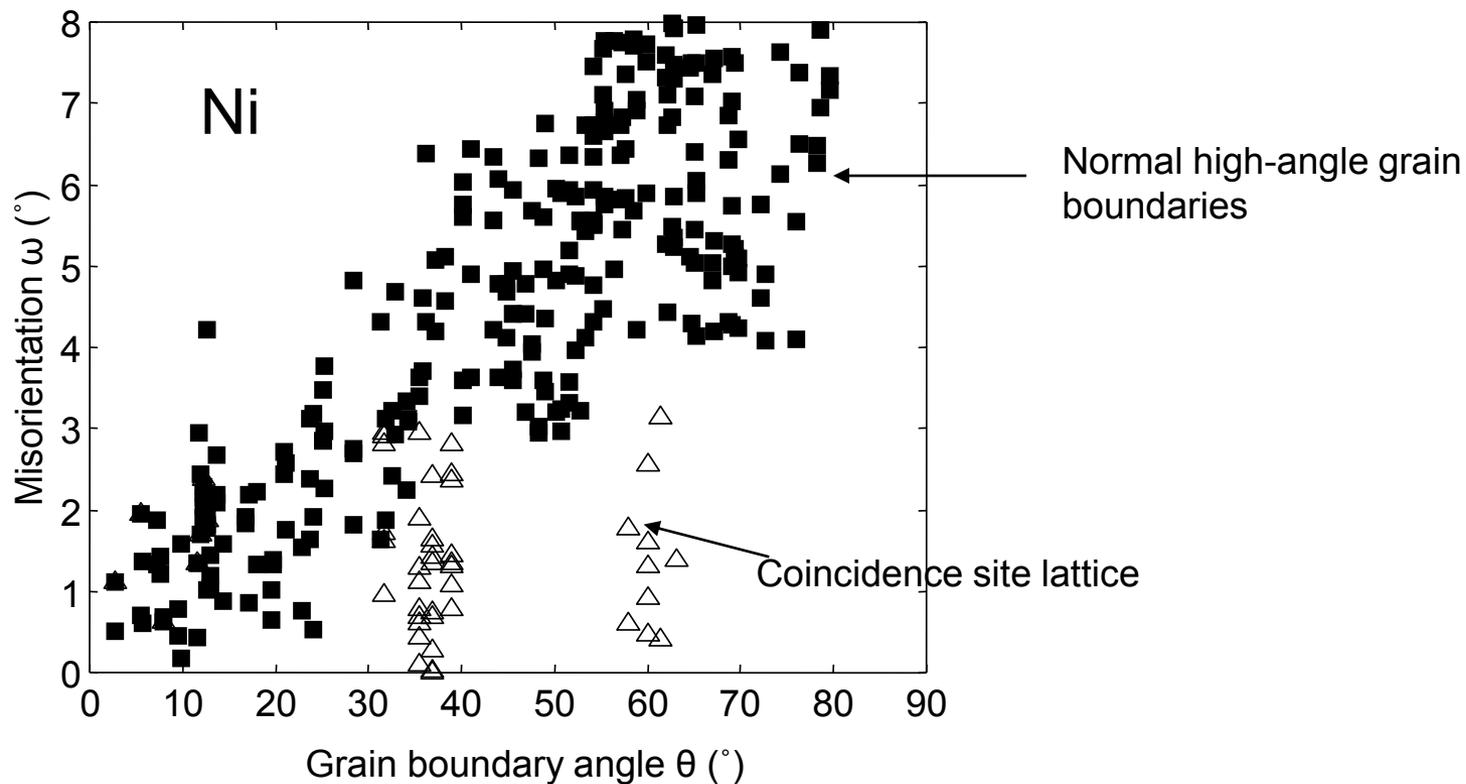
Deformation in polycrystals illustrates grain boundary behavior



Indexation

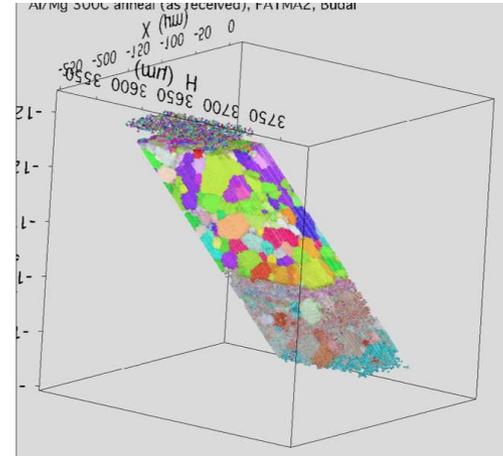


Deformation induced rotations across grain boundaries sensitive to boundary type



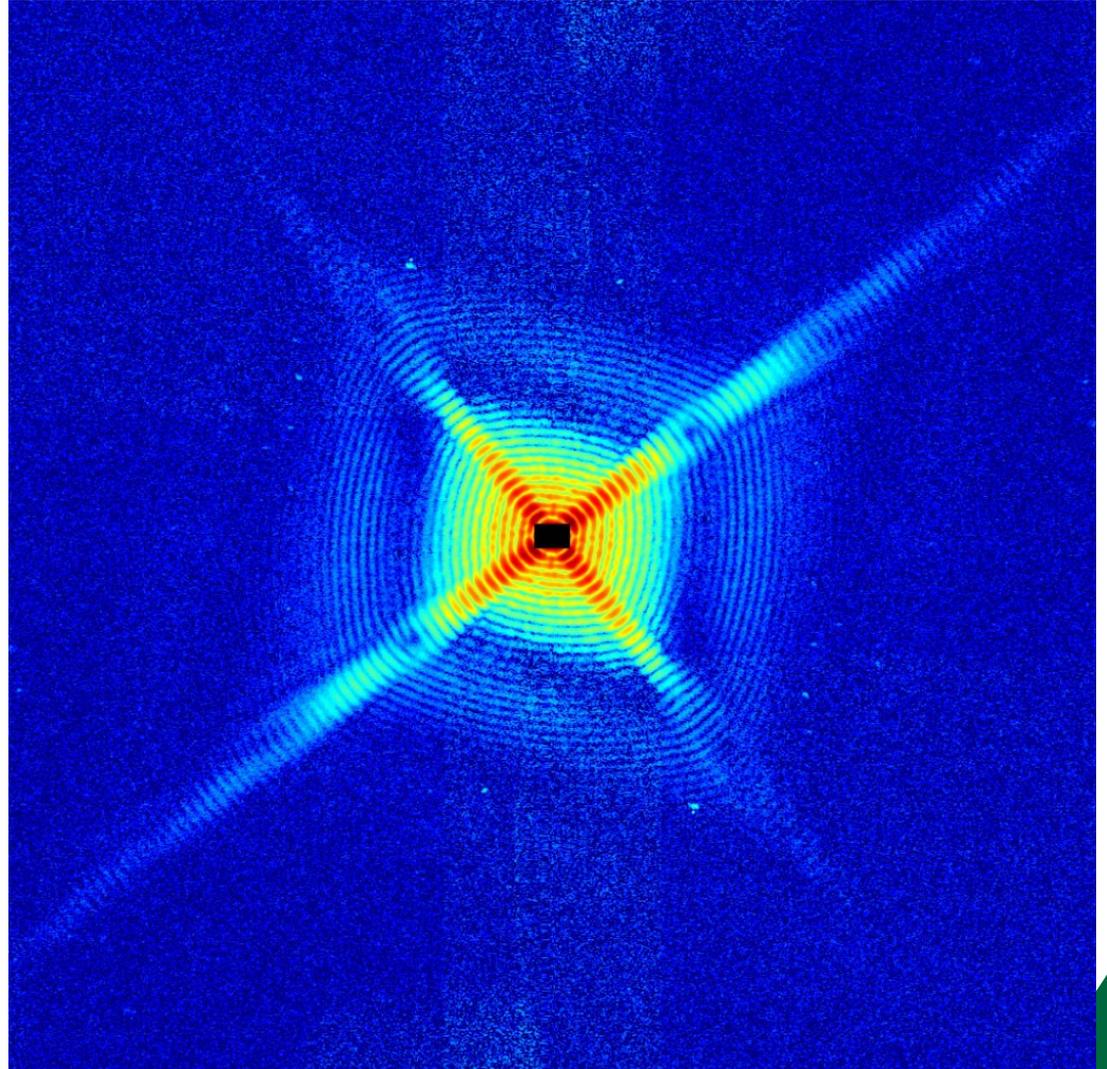
Do neural networks provide a path forward?

- Visualization of 3D tensor data unsolved problem
- Human mind well adapted to 3D visualization based on binocular 3D data.
- Neural network not “limited” by streamlined processing of human brain



Coherent diffraction offers promise for atomic resolution with focused beams

- **Focusing**
 - Better spatial resolution
 - Poorer field-of-view
- **2 nm with 3rd generation source and 1 μm focal spot**
- **2 \AA with 10 nm spot- or 4th generation source**

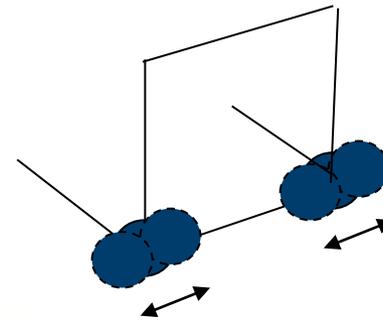
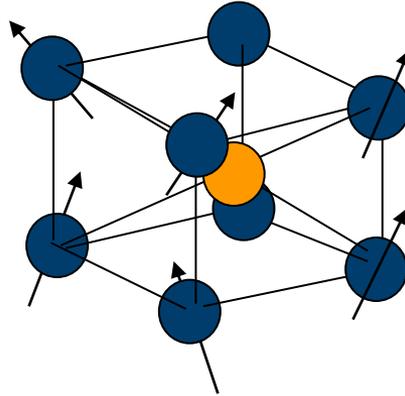


Neutron microdiffraction additional opportunities

Magnetism

Atomic motions

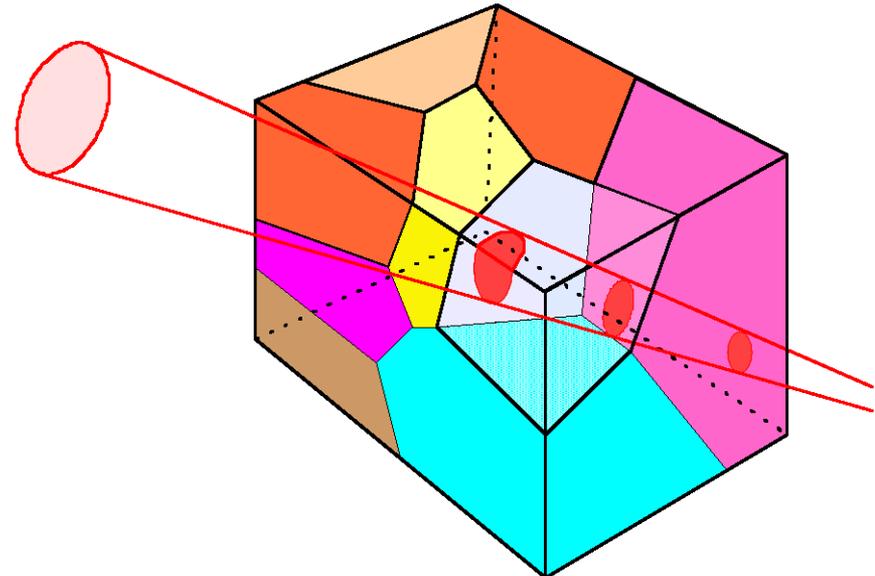
Low Z materials



Nobel prize to Shull and Brockhou.

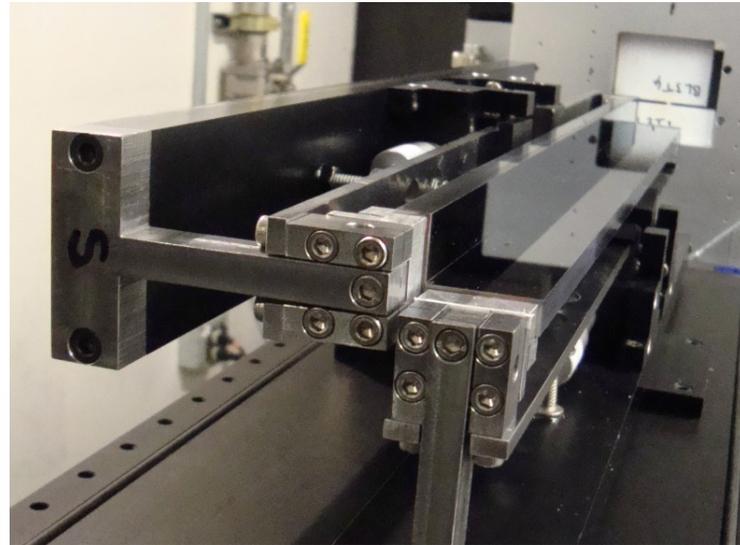
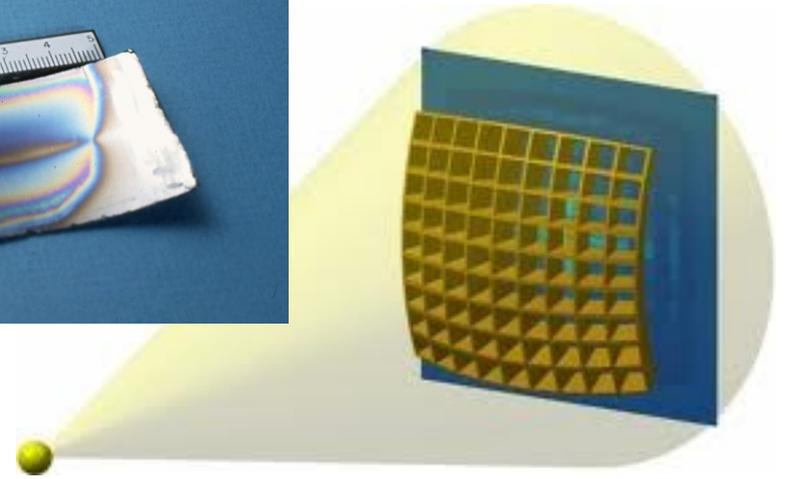
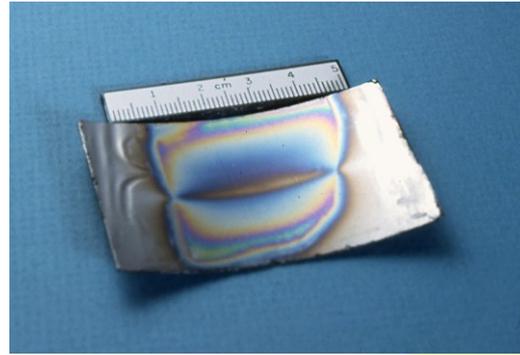
Focused beams extend neutron science

- Inhomogeneous samples
- Small samples in environmental chambers
- Spatial resolved distributions deep in samples



Neutron microfocusing optics also evolving

- Sagittal focusing optics < 300 μm
- Lobster eye optics ?
- NMM < 100 μm
- Wolter optics < 200 μm



Even the most intense neutron source must be used efficiently

Neutron sources 10^{12} lower brilliance than advanced x-ray

Neutrons expensive 10^{13} more expensive!

10^{-16} \$ /x-ray

10^{-3} \$ /neutron

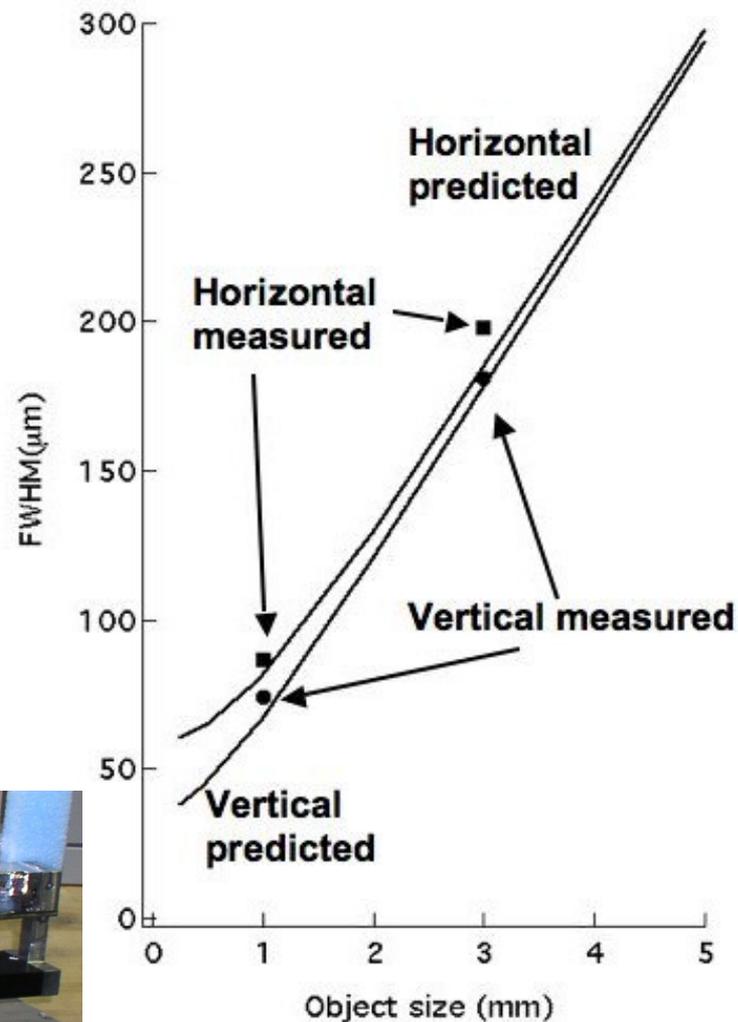
Increase divergence/bandpass

10^{-9} \$/ neutron



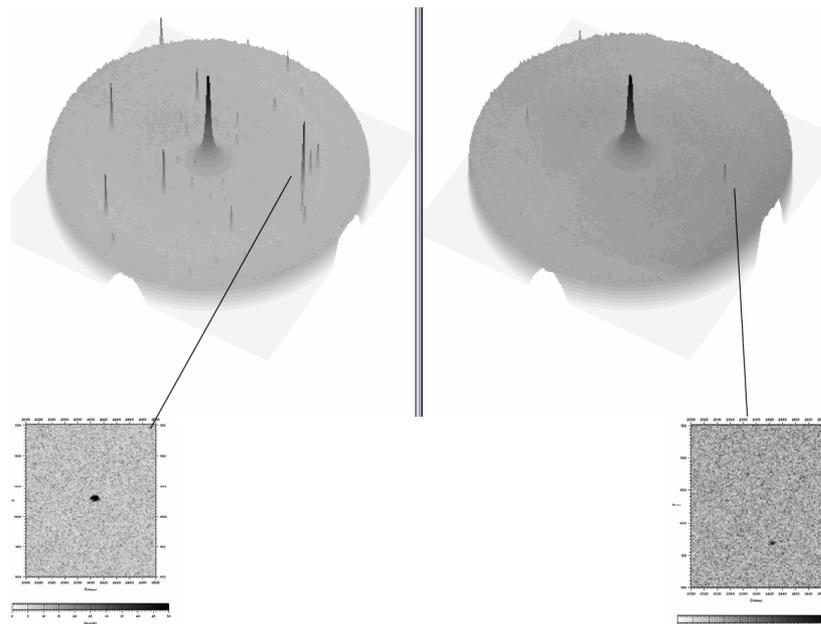
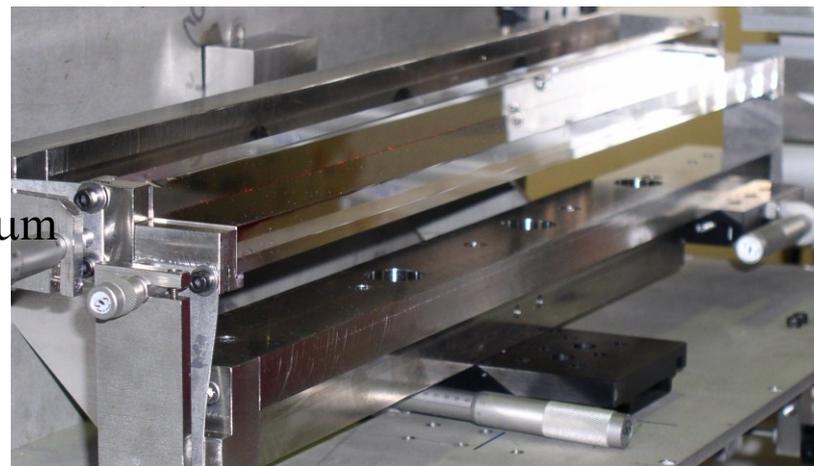
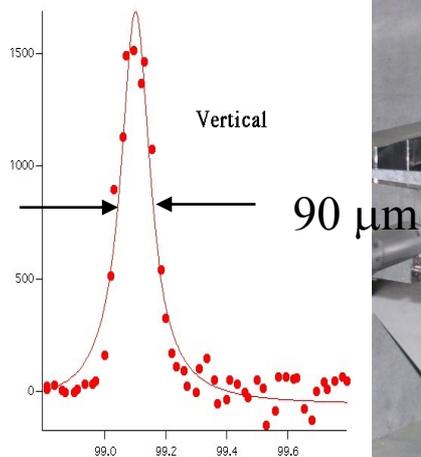
SNAP experiments diffraction high pressure cells

- Focusing optics work near theoretical limit
- Minor improvements should enable 25 micron measurements



Neutron mirrors produce microbeams

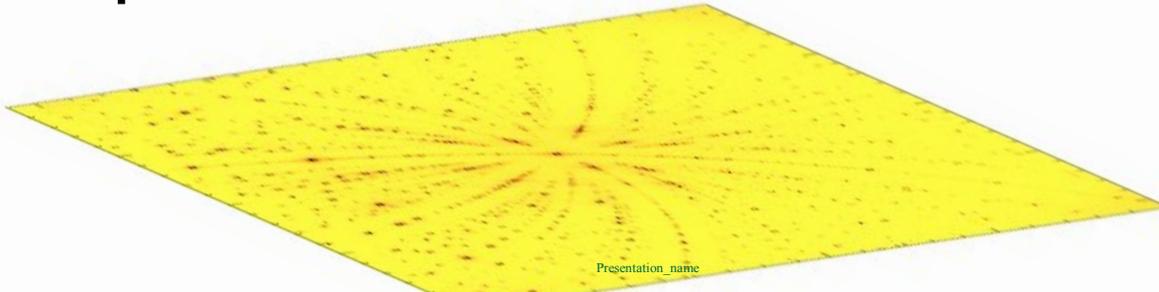
- Better signal-to-noise
- Resolve inhomogeneities
- Map crystal distributions



Useable 25 μm beams?

Conclusion: Microdiffraction

- **Addresses long-standing issues materials physics**
- **Techniques and instrumentation rapidly evolving**
- **Answers specific questions about materials systems (Energy materials)**
- **Extend x-ray and neutron characterization to new classes of samples.**
 - **Dangerous**
 - **Inhomogeneous**
 - **Samples in extreme environments**



Materials structure tiny- intrinsically 3D
And spatial resolution- is needed urgently
The frontiers moving quickly now-excitements in the air
Though ask the average person- they really couldn't care

CHORUS

Nondispersive - optics change what we can see

Mesostructure- resolved by crystallography

Atomic defects quantified - so that we can surmise

Emergent structures origins- at the mesoscopic size

New optics and new methods- extend what we can do

With spatial resolution- time resolution too

Nondestructive lets us watch- materials deep inside

Chambers or complex system - where once they could hide

Emerging applications- I've tried to show a few

Energy materials- have challenges quite new

With x-ray and neutron beams- we now are freed

To study these materials- on the scale that we need

